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198 Champion Court

San Jose, CA 95134-1709

408-943-2600

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Single-Chip IEEE 802.11 b/g/n MAC/Baseband/Radio

GENERAL DESCRIPTION

The Broadcom[®] BCM43364 is a highly integrated single-chip solution and offers the lowest RBOM in the industry for Internet of Things (IoT) and a wide range of other portable devices. The chip includes a 2.4 GHz WLAN IEEE 802.11 b/g/n MAC/baseband/radio. In addition, it integrates a power amplifier (PA) that meets the output power requirements of most handheld systems, a low-noise amplifier (LNA) for best-in-class receiver sensitivity, and an internal transmit/receive (iTR) RF switch, further reducing the overall solution cost and printed circuit board area.

The WLAN host interface supports gSPI and SDIO v2.0 modes, providing a raw data transfer rate up to 200 Mbps when operating in 4-bit mode at a 50 MHz bus frequency.

Using advanced design techniques and process technology to reduce active and idle power, the BCM43364 is designed to address the needs of highly mobile devices that require minimal power consumption and compact size. It includes a power management unit that simplifies the system power topology while maximizing battery life.

FEATURES

IEEE 802.11x Key Features

- Single-band 2.4 GHz IEEE 802.11b/g/n.
- Support for 2.4 GHz Broadcom TurboQAM[®] data rates (256-QAM) and 20 MHz channel bandwidth.
- Integrated iTR switch supports a single 2.4 GHz antenna.
- Supports explicit IEEE 802.11n transmit beamforming.
- Tx and Rx low-density parity check (LDPC) support for improved range and power efficiency.
- Supports standard SDIO v2.0 and gSPI host interfaces.
- Supports space-time block coding (STBC) in the receiver.
- Integrated ARM Cortex-M3 processor and on-chip memory for complete WLAN subsystem functionality, minimizing the need to wake up the applications processor for standard WLAN functions. This allows for further minimization of power consumption, while maintaining the ability to field-upgrade with future features. On-chip memory includes 512 KB SRAM and 640 KB ROM.
- OneDriver[™] software architecture for easy migration from existing embedded WLAN.

WLAN Host I/F

WL, REG_ON WL, HOST_WAKE SDIO*/SPI

CLK_REQ REF_CLK (19.2, 26, or 37.4 MHz)

WLAN TX/RX

BCM43364

Figure 1: BCM43364 System Block Diagram

FEATURES

General Features

- · Support diversity antenna.
- Supports a battery voltage range from 3.0V to 4.8V with an internal switching regulator.
- Programmable dynamic power management.
- 4 Kbit one-time programmable (OTP) memory for storing board parameters.
- Can be routed on low-cost 1-x-1 PCB stack-ups.
- 74-ball WLBGA package (4.87 mm × 2.87 mm, 0.4 mm pitch).

- · Security:
 - WPA and WPA2 (Personal) support for powerful encryption and authentication.
 - AES in WLAN hardware for faster data encryption and IEEE 802.11i compatibility.
 - Reference WLAN subsystem provides Cisco Compatible Extensions (CCX, CCX 2.0, CCX 3.0, CCX 4.0, CCX 5.0).
 - Reference WLAN subsystem provides Wi-Fi protected setup (WPS).
- Worldwide regulatory support: Global products supported with worldwide homologated design.

Broadcom Corporation 5300 California Avenue Irvine, CA 92617

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Revision History

Revision	Date	Change Description
43364-DS102-R	10/05/15	Updated:
		Table 9: "WLBGA Signal Descriptions," on page 49
		Table 12: "I/O States," on page 53
43364-DS101-R	08/06/15	Updated:
		 Figure 3: "Typical Power Topology (1 of 2)," on page 14.
		 Figure 4: "Typical Power Topology (2 of 2)," on page 15.
		 Figure 22: "74-Ball WLBGA Ball Map (Bottom View)," on page 44.
		 Table 7: "BCM43364 WLBGA Ball List — Ordered By Ball Number," on page 45.
		 Table 8: "BCM43364 WLBGA Ball List — Ordered By Ball Name," on page 48.
		Table 9: "WLBGA Signal Descriptions," on page 49.
		Table 12: "I/O States," on page 53.
		• Table 18: "WLAN 2.4 GHz Receiver Performance Specifications," on page 59.
		 Table 19: "WLAN 2.4 GHz Transmitter Performance Specifications," on page 62.
		 Table 25: "2.4 GHz Mode WLAN Power Consumption," on page 70.
43364-DS100-R	12/08/14	Initial release

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About This Document

Purpose and Audience

This document provides details of the functional, operational, and electrical characteristics of the Broadcom[®] BCM43364. It is intended for hardware design, application, and OEM engineers.

Acronyms and Abbreviations

In most cases, acronyms and abbreviations are defined on first use.

For a comprehensive list of acronyms and other terms used in Broadcom documents, go to: http://www.broadcom.com/press/glossary.php.

Document Conventions

The following conventions may be used in this document:

Convention	Description	
Bold User input and actions: for example, type exit, click OK, press Alt+C		
Monospace Code: #include <iostream> HTML: Command line commands and parameters: wl [-1] <command/></iostream>		
<>	Placeholders for required elements: enter your <username> or w1 <command/></username>	
[]	Indicates optional command-line parameters: w1 [-1] Indicates bit and byte ranges (inclusive): [0:3] or [7:0]	

Technical Support

Broadcom provides customer access to a wide range of information, including technical documentation, schematic diagrams, product bill of materials, PCB layout information, and software updates through its customer support portal (https://support.broadcom.com). For a CSP account, contact your Sales or Engineering support representative.

In addition, Broadcom provides other product support through its Downloads and Support site (http://www.broadcom.com/support/).

Section 1: Overview

Overview

The Broadcom[®] BCM43364 provides the highest level of integration for IoT and wireless automation system, with integrated IEEE 802.11 b/g/n. It provides a small form-factor solution with minimal external components to drive down cost for mass volumes and allows for handheld device flexibility in size, form, and function. The BCM43364 is designed to address the needs of highly mobile devices that require minimal power consumption and reliable operation.

Figure 2 on page 11 shows the interconnection of all the major physical blocks in the BCM43364 and their associated external interfaces, which are described in greater detail in subsequent sections.

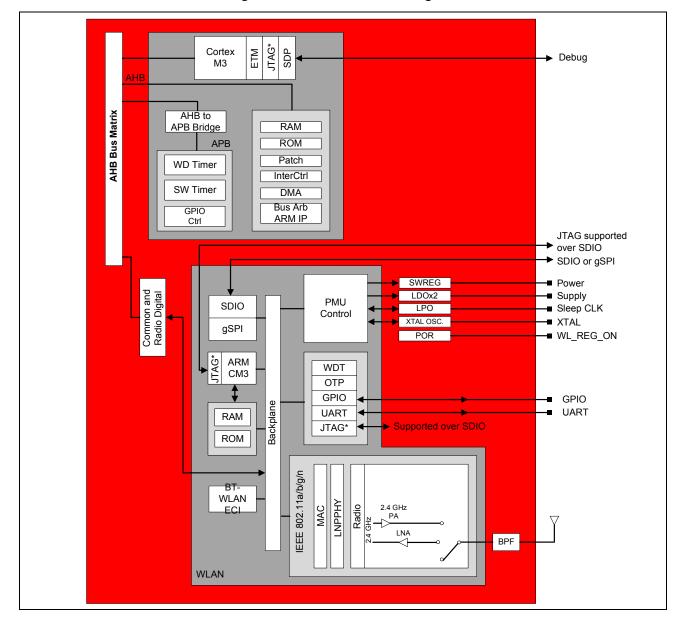


Figure 2: BCM43364 Block Diagram

Features

The BCM43364 supports the following WLAN features:

- IEEE 802.11b/g/n single-band radio with an internal power amplifier, LNA, and T/R switch
- On-chip WLAN driver execution capable of supporting IEEE 802.11 functionality
- WLAN host interface options:
 - SDIO v2.0, including default and high-speed timing.
 - gSPI—up to a 50 MHz clock rate

Standards Compliance

The BCM43364 supports the following standards:

- IEEE 802.11n—Handheld Device Class (Section 11)
- IEEE 802.11b
- IEEE 802.11g
- IEEE 802.11d
- IEEE 802.11h
- IEEE 802.11i

The BCM43364 will support the following future drafts/standards:

- IEEE 802.11r Fast Roaming (between APs)
- IEEE 802.11k Resource Management
- IEEE 802.11w Secure Management Frames
- IEEE 802.11 Extensions:
- IEEE 802.11e QoS Enhancements (as per the WMM specification is already supported)
- IEEE 802.11i MAC Enhancements
- IEEE 802.11r Fast Roaming Support
- IEEE 802.11k Radio Resource Measurement

The BCM43364 supports the following security features and proprietary protocols:

- Security:
 - WEP
 - WPA Personal
 - WPA2 Personal
 - WMM
 - WMM-PS (U-APSD)
 - WMM-SA
 - WAPI
 - AES (Hardware Accelerator)
 - TKIP (host-computed)
 - CKIP (SW Support)
- · Proprietary Protocols:
 - CCXv2
 - CCXv3
 - CCXv4
 - CCXv5
- IEEE 802.15.2 Coexistence Compliance on silicon solution compliant with IEEE 3-wire requirements.

Section 2: Power Supplies and Power Management

Power Supply Topology

One Buck regulator, multiple LDO regulators, and a power management unit (PMU) are integrated into the BCM43364. All regulators are programmable via the PMU to simplify the power supply.

A single VBAT (3.0V to 4.8V DC maximum) and VDDIO supply (1.8V to 3.3V) can be used, with all additional voltages being provided by the regulators in the BCM43364.

The WL_REG_ON control signal is used to power up the regulators and take the respective circuit blocks out of reset. The CBUCK CLDO and LNLDO power up when any of the reset signals are deasserted. All regulators are powered down only when WL_REG_ON is deasserted. The CLDO and LNLDO can be turned on and off based on the dynamic demands of the digital baseband.

The BCM43364 allows for an extremely low power-consumption mode by completely shutting down the CBUCK, CLDO, and LNLDO regulators. When in this state, LPLDO1 provides the BCM43364 with all required voltage, further reducing leakage currents.



Note: VBAT should be connected to the LDO_VDDBAT5V and SR_VDDBAT5V pins of the device.



Note: VDDIO should be connected to the SYS_VDDIO and WCC_VDDIO pins of the device.

BCM43364 PMU Features

The PMU supports the following:

- VBAT to 1.35Vout (170 mA nominal, 370 mA maximum) Core-Buck (CBUCK) switching regulator
- VBAT to 3.3Vout (250 mA nominal, 450 mA maximum 800 mA peak maximum) LDO3P3
- 1.35V to 1.2Vout (100 mA nominal, 150 mA maximum) LNLDO
- 1.35V to 1.2Vout (80 mA nominal, 200 mA maximum) CLDO with bypass mode for deep sleep
- Additional internal LDOs (not externally accessible)
- PMU internal timer auto-calibration by the crystal clock for precise wake-up timing from extremely low power-consumption mode.

Figure 3 on page 14 and Figure 4 on page 15 show the typical power topology of the BCM43364.

BCM43364 Preliminary Data Sheet BCM43364 PMU Features

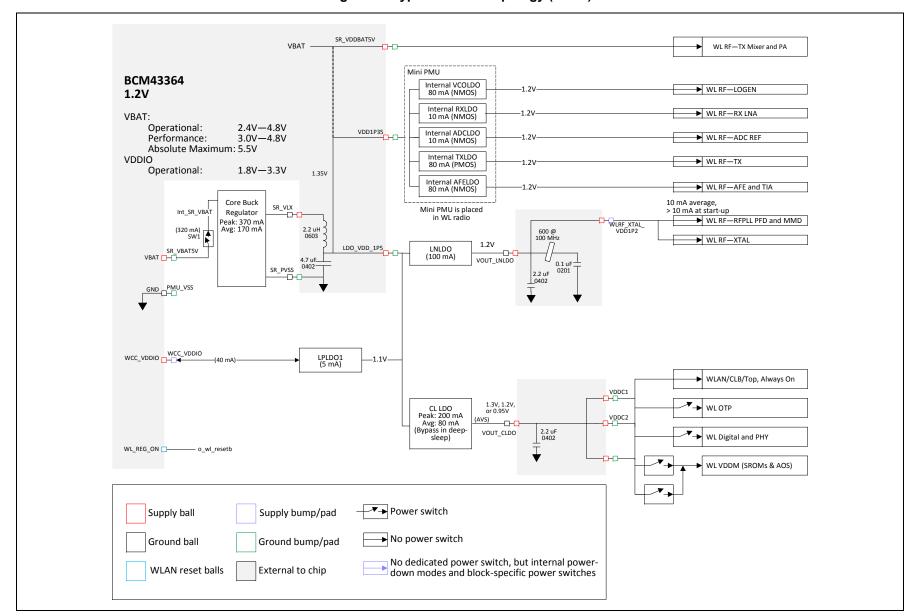


Figure 3: Typical Power Topology (1 of 2)

BCM43364 Preliminary Data Sheet BCM43364 PMU Features

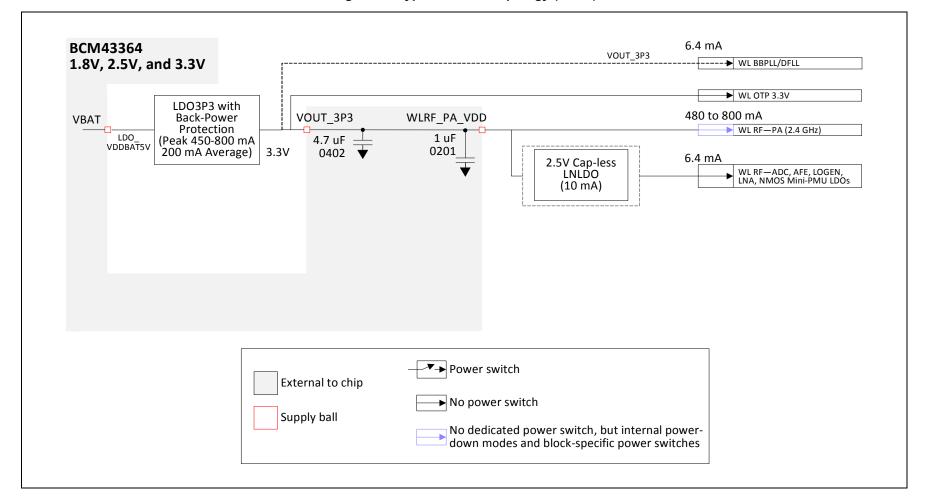


Figure 4: Typical Power Topology (2 of 2)

WLAN Power Management

The BCM43364 has been designed with the stringent power consumption requirements of mobile devices in mind. All areas of the chip design are optimized to minimize power consumption. Silicon processes and cell libraries were chosen to reduce leakage current and supply voltages. Additionally, the BCM43364 integrated RAM is a high volatile memory with dynamic clock control. The dominant supply current consumed by the RAM is leakage current only. Additionally, the BCM43364 includes an advanced WLAN power management unit (PMU) sequencer. The PMU sequencer provides significant power savings by putting the BCM43364 into various power management states appropriate to the operating environment and the activities that are being performed. The power management unit enables and disables internal regulators, switches, and other blocks based on a computation of the required resources and a table that describes the relationship between resources and the time needed to enable and disable them. Power-up sequences are fully programmable. Configurable, free-running counters (running at the 32.768 kHz LPO clock) in the PMU sequencer are used to turn on/turn off individual regulators and power switches. Clock speeds are dynamically changed (or gated altogether) for the current mode. Slower clock speeds are used wherever possible.

The BCM43364 WLAN power states are described as follows:

- Active mode: All WLAN blocks in the BCM43364 are powered up and fully functional with active carrier sensing and frame transmission and receiving. All required regulators are enabled and put in the most efficient mode based on the load current. Clock speeds are dynamically adjusted by the PMU sequencer.
- Doze mode: The radio, analog domains, and most of the linear regulators are powered down. The rest of
 the BCM43364 remains powered up in an IDLE state. All main clocks (PLL, crystal oscillator) are shut down
 to reduce active power to the minimum. The 32.768 kHz LPO clock is available only for the PMU
 sequencer. This condition is necessary to allow the PMU sequencer to wake up the chip and transition to
 Active mode. In Doze mode, the primary power consumed is due to leakage current.
- Deep-sleep mode: Most of the chip, including analog and digital domains, and most of the regulators are
 powered off. Logic states in the digital core are saved and preserved to retention memory in the always-on
 domain before the digital core is powered off. To avoid lengthy hardware reinitialization, the logic states in
 the digital core are restored to their pre-deep-sleep settings when a wake-up event is triggered by an
 external interrupt, a host resume through the SDIO bus, or by the PMU timers.
- Power-down mode: The BCM43364 is effectively powered off by shutting down all internal regulators. The chip is brought out of this mode by external logic re-enabling the internal regulators.

PMU Sequencing

The PMU sequencer is used to minimize system power consumption. It enables and disables various system resources based on a computation of required resources and a table that describes the relationship between resources and the time required to enable and disable them.

Resource requests can derive from several sources: clock requests from cores, the minimum resources defined in the *ResourceMin* register, and the resources requested by any active resource request timers. The PMU sequencer maps clock requests into a set of resources required to produce the requested clocks.

Each resource is in one of the following four states:

- · enabled
- disabled
- transition_on
- · transition off

The timer value is 0 when the resource is enabled or disabled and nonzero during state transition. The timer is loaded with the time_on or time_off value of the resource when the PMU determines that the resource must be enabled or disabled. That timer decrements on each 32.768 kHz PMU clock. When it reaches 0, the state changes from transition_off to disabled or transition_on to enabled. If the time_on value is 0, the resource can transition immediately from disabled to enabled. Similarly, a time_off value of 0 indicates that the resource can transition immediately from enabled to disabled. The terms *enable sequence* and *disable sequence* refer to either the immediate transition or the timer load-decrement sequence.

During each clock cycle, the PMU sequencer performs the following actions:

- · Computes the required resource set based on requests and the resource dependency table.
- Decrements all timers whose values are nonzero. If a timer reaches 0, the PMU clears the ResourcePending bit for the resource and inverts the ResourceState bit.
- Compares the request with the current resource status and determines which resources must be enabled or disabled.
- Initiates a disable sequence for each resource that is enabled, no longer being requested, and has no powered-up dependents.
- Initiates an enable sequence for each resource that is disabled, is being requested, and has all of its
 dependencies enabled.

Power-Off Shutdown

The BCM43364 provides a low-power shutdown feature that allows the device to be turned off while the host, and any other devices in the system, remain operational. When the BCM43364 is not needed in the system, VDDIO_RF and VDDC are shut down while VDDIO remains powered. This allows the BCM43364 to be effectively off while keeping the I/O pins powered so that they do not draw extra current from any other devices connected to the I/O.

During a low-power shutdown state, provided VDDIO remains applied to the BCM43364, all outputs are tristated, and most input signals are disabled. Input voltages must remain within the limits defined for normal operation. This is done to prevent current paths or create loading on any digital signals in the system, and enables the BCM43364 to be fully integrated in an embedded device and to take full advantage of the lowest power-savings modes.

When the BCM43364 is powered on from this state, it is the same as a normal power-up, and the device does not retain any information about its state from before it was powered down.

Power-Up/Power-Down/Reset Circuits

The BCM43364 has two signals (see Table 1) that enable or disable the WLAN circuits and the internal regulator blocks, allowing the host to control power consumption. For timing diagrams of these signals and the required power-up sequences, see Section 14: "Power-Up Sequence and Timing," on page 76.

Table 1: Power-Up/Power-Down/Reset Control Signals

Signal	Description
WL_REG_ON	This signal is used by the PMU to power-up the WLAN section. When this pin is high, the regulators are enabled and the WLAN section is out of reset. When this pin is low, the WLAN section is in reset. This pin has an internal 200 k Ω pull-down resistor that is enabled by default. It can be disabled through programming.

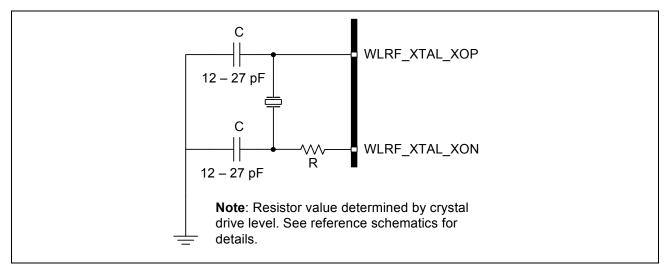
Section 3: Frequency References

An external crystal is used for generating all radio frequencies and normal operation clocking. As an alternative, an external frequency reference driven by a temperature-compensated crystal oscillator (TCXO) signal may be used. No software settings are required to differentiate between the two. In addition, a low-power oscillator (LPO) is provided for lower power mode timing.

Crystal Interface and Clock Generation

The BCM43364 can use an external crystal to provide a frequency reference. The recommended configuration for the crystal oscillator, including all external components, is shown in Figure 5. Consult the reference schematics for the latest configuration.

Figure 5: Recommended Oscillator Configuration



The BCM43364 uses a fractional-N synthesizer to generate the radio frequencies, clocks, and data/packet timing so that it can operate using numerous frequency references. The frequency reference can be an external source such as a TCXO or a crystal interfaced directly to the BCM43364.

The default frequency reference setting is a 37.4 MHz crystal or TCXO. The signal requirements and characteristics for the crystal interface are shown in Table 2 on page 20.



Note: Although the fractional-N synthesizer can support many reference frequencies, frequencies other than the default require support to be added in the driver, plus additional extensive system testing. Contact Broadcom for further details.

TCXO

As an alternative to a crystal, an external precision TCXO can be used as the frequency reference, provided that it meets the phase noise requirements listed in Table 2 on page 20.

If the TCXO is dedicated to driving the BCM43364, it should be connected to the WLRF_XTAL_XOP pin through an external capacitor with value ranges from 200 pF to 1000 pF as shown in Figure 6.

Figure 6: Recommended Circuit to Use with an External Dedicated TCXO

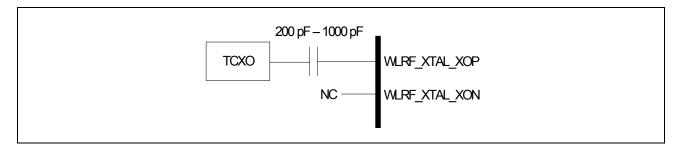


Table 2: Crystal Oscillator and External Clock Requirements and Performance

		Crys	tal		Exter Refer		equency	
Parameter	Conditions/Notes	Min.	Тур.	Max.	Min.	Тур.	Мах.	Units
Frequency	-	_	37.4 ^a	_	_	_	_	MHz
Crystal load capacitance	-	-	12	_	-	_	_	pF
ESR	-	_	_	60	_	_	_	Ω
Input Impedance	Resistive	-	-	_	10k	100k	_	Ω
(WLRF_XTAL_XOP)	Capacitive	-	-	_	_	-	7	pF
WLRF_XTAL_XOP input voltage	AC-coupled analog signal	_	-	_	400 ^b	-	1260	mV_{p-p}
WLRF_XTAL_XOP input low level	DC-coupled digital signal	_	_	_	0	_	0.2	V
WLRF_XTAL_XOP input high level	DC-coupled digital signal	_	_	_	1.0	_	1.26	V
Frequency tolerance Initial + over temperature	_	-20	_	20	-20	_	20	ppm
Duty cycle	37.4 MHz clock	_	_	_	40	50	60	%
Phase Noise ^{c, d, e}	37.4 MHz clock at 10 kHz offset	_	_	_	_	_	-129	dBc/Hz
(IEEE 802.11 b/g)	37.4 MHz clock at 100 kHz offset	t —	_	_	_	_	-136	dBc/Hz
Phase Noise ^{c, d, e}	37.4 MHz clock at 10 kHz offset	_	_	_	_	_	-134	dBc/Hz
(IEEE 802.11n, 2.4 GHz)	37.4 MHz clock at 100 kHz offset	t –	_	-	-	-	-141	dBc/Hz

Table 2: Crystal Oscillator and External Clock Requirements and Performance (Cont.)

		Crystal		External Frequency Reference				
Parameter	Conditions/Notes	Min.	Тур.	Мах.	Min.	Тур.	Мах.	Units
Phase Noise ^{c, d, e}	37.4 MHz clock at 10 kHz offset	_	_	-	_	_	-140	dBc/Hz
(256-QAM)	37.4 MHz clock at 100 kHz offset	_	_	-	_	_	-147	dBc/Hz

- a. The frequency step size is approximately 80 Hz. The BCM43364 does not auto-detect the reference clock frequency; the frequency is specified in the software and/or NVRAM file.
- b. To use 256-QAM, a 800 mV minimum voltage is required.
- c. For a clock reference other than 37.4 MHz, 20 × log10(f/37.4) dB should be added to the limits, where f = the reference clock frequency in MHz.
- d. Phase noise is assumed flat above 100 kHz.
- e. The BCM43364 supports a 26 MHz reference clock sharing option. See the phase noise requirement in the table.

External 32.768 kHz Low-Power Oscillator

The BCM43364 uses a secondary low-frequency sleep clock for low-power mode timing. Either the internal low-precision LPO or an external 32.768 kHz precision oscillator is required. The internal LPO frequency range is approximately 33 kHz \pm 30% over process, voltage, and temperature, which is adequate for some applications. However, one trade-off caused by this wide LPO tolerance is a small current consumption increase during power save mode that is incurred by the need to wake up earlier to avoid missing beacons.

Whenever possible, the preferred approach is to use a precision external 32.768 kHz clock that meets the requirements listed in Table 3 on page 21.



Note: The BCM43364 will auto-detect the LPO clock. If it senses a clock on the EXT_SLEEP_CLK pin, it will use that clock. If it doesn't sense a clock, it will use its own internal LPO.

- To use the internal LPO: Tie EXT SLEEP CLK to ground. Do not leave this pin floating.
- To use an external LPO: Connect the external 32.768 kHz clock to EXT_SLEEP_CLK.

Table 3: External 32.768 kHz Sleep-Clock Specifications

Parameter	LPO Clock	Units
Nominal input frequency	32.768	kHz
Frequency accuracy	±200	ppm
Duty cycle	30–70	%
Input signal amplitude	200–3300	mV, p-p
Signal type	Square wave or sine wave	_
Input impedance ^a	>100	kΩ
·	<5	pF
Clock jitter	<10,000	ppm

a. When power is applied or switched off.

Section 4: WLAN System Interfaces

SDIO v2.0

The BCM43364 WLAN section supports SDIO version 2.0. for both 1-bit (25 Mbps) and 4-bit modes (100 Mbps), as well as high speed 4-bit mode (50 MHz clocks—200 Mbps). It has the ability to map the interrupt signal on a GPIO pin. This out-of-band interrupt signal notifies the host when the WLAN device wants to turn on the SDIO interface. The ability to force control of the gated clocks from within the WLAN chip is also provided.

SDIO mode is enabled using the strapping option pins. See Table 10 on page 52 for details.

Three functions are supported:

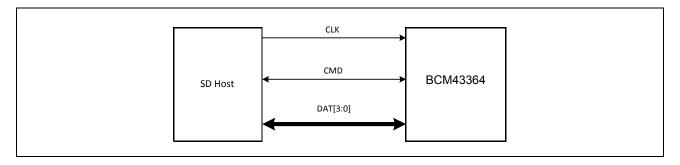
- Function 0 standard SDIO function. The maximum block size is 32 bytes.
- Function 1 backplane function to access the internal System-on-a-Chip (SoC) address space. The maximum block size is 64 bytes.
- Function 2 WLAN function for efficient WLAN packet transfer through DMA. The maximum block size is 512 bytes.

SDIO Pin Descriptions

Table 4: SDIO Pin Descriptions

	SD 4-Bit Mode		SD 1-Bit Mode		gSPI Mode
DATA0	Data line 0	DATA	Data line	DO	Data output
DATA1	Data line 1 or Interrupt	IRQ	Interrupt	IRQ	Interrupt
DATA2	Data line 2	NC	Not used	NC	Not used
DATA3	Data line 3	NC	Not used	CS	Card select
CLK	Clock	CLK	Clock	SCLK	Clock
CMD	Command line	CMD	Command line	DI	Data input

Figure 7: Signal Connections to SDIO Host (SD 4-Bit Mode)



SD Host

CMD

BCM43364

IRQ

Figure 8: Signal Connections to SDIO Host (SD 1-Bit Mode)

Generic SPI Mode

In addition to the full SDIO mode, the BCM43364 includes the option of using the simplified generic SPI (gSPI) interface/protocol. Characteristics of the gSPI mode include:

- Up to 50 MHz operation
- · Fixed delays for responses and data from the device
- Alignment to host gSPI frames (16 or 32 bits)
- · Up to 2 KB frame size per transfer
- · Little-endian and big-endian configurations
- A configurable active edge for shifting
- Packet transfer through DMA for WLAN

The gSPI mode is enabled using the strapping option pins. See Table 10 on page 52 for details.

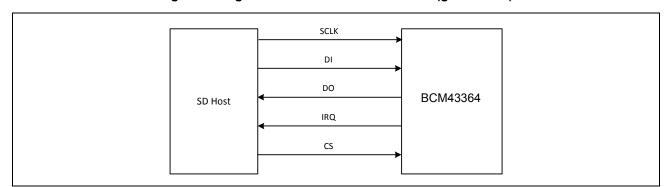


Figure 9: Signal Connections to SDIO Host (gSPI Mode)

SPI Protocol

The SPI protocol supports both 16-bit and 32-bit word operation. Byte endianess is supported in both modes. Figure 10 and Figure 11 on page 25 show the basic write and write/read commands.

Write Protocol Command Data Data C3 C2 C1 C0 D3 D2 D1 D0 D7 D6 D5 D4 Din 32 bit Little Endian 0000 0000 0000 0000 0000 0000 Dout C1 C0 C3 C2 D1 D0 D3 D2 D5 D4 D7 D6 Din 16 bit Little Endian 0000 0000 0000 0000 0000 Dout 0000 C0 C1 C2 C3 D0 D1 D2 D3 D4 D5 D6 D7 Din 32 bit Big Endian 0000 0000 0000 0000 0000 0000 Dout C0 C1 C2 C3 D0 D1 D2 D3 D4 D5 D6 D7 16 bit Big Endian 0000 0000 0000 0000 0000 0000 Dout

Figure 10: gSPI Write Protocol

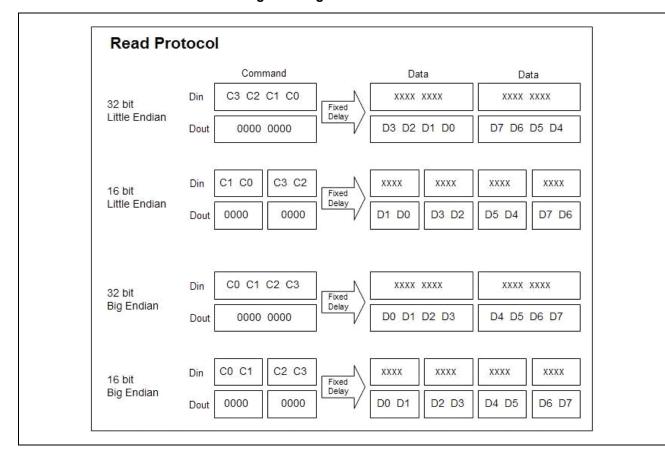


Figure 11: gSPI Read Protocol

Command Structure

The gSPI command structure is 32 bits. The bit positions and definitions are shown in Figure 12.

BCM_SPID Command Structure 31 30 29 28 27 11 10 0 С Α F1 F0 Address - 17 bits Packet length - 11bits * * 11'h0 = 2048 bytes Function No: 00 - Func 0: All SPI-specific registers 01 - Func 1: Registers and memories belonging to other blocks in the chip (64 bytes max) 10 - Func 2: DMA channel 1. WLAN packets up to 2048 bytes. 11 - Func 3: DMA channel 2 (optional). Packets up to 2048 bytes. Access: 0 - Fixed address 1 - Incremental address Command : 0 − Read 1 - Write

Figure 12: gSPI Command Structure

Write

The host puts the first bit of the data onto the bus half a clock-cycle before the first active edge following the CS going low. The following bits are clocked out on the falling edge of the gSPI clock. The device samples the data on the active edge.

Write/Read

The host reads on the rising edge of the clock requiring data from the device to be made available before the first rising-clock edge of the data. The last clock edge of the fixed delay word can be used to represent the first bit of the following data word. This allows data to be ready for the first clock edge without relying on asynchronous delays.

Read

The read command always follows a separate write to set up the WLAN device for a read. This command differs from the write/read command in the following respects: a) chip selects go high between the command/address and the data, and b) the time interval between the command/address is not fixed.

Status

The gSPI interface supports status notification to the host after a read/write transaction. This status notification provides information about packet errors, protocol errors, available packets in the RX queue, etc. The status information helps reduce the number of interrupts to the host. The status-reporting feature can be switched off using a register bit, without any timing overhead. The gSPI bus timing for read/write transactions with and without status notification are as shown in Figure 13 below and Figure 14 on page 28. See Table 5 on page 28 for information on status-field details.

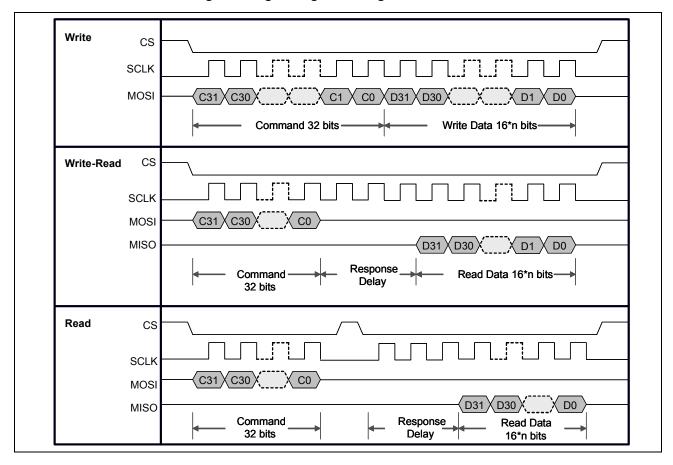


Figure 13: gSPI Signal Timing Without Status

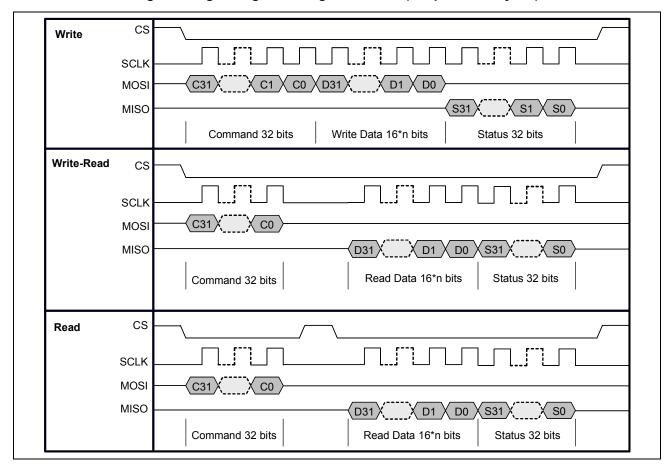


Figure 14: gSPI Signal Timing with Status (Response Delay = 0)

Table 5: gSPI Status Field Details

Bit	Name	Description
0	Data not available	The requested read data is not available.
1	Underflow	FIFO underflow occurred due to current (F2, F3) read command.
2	Overflow	FIFO overflow occurred due to current (F1, F2, F3) write command.
3	F2 interrupt	F2 channel interrupt
5	F2 RX ready	F2 FIFO is ready to receive data (FIFO empty).
7	Reserved	-
8	F2 packet available	Packet is available/ready in F2 TX FIFO.
9:19	F2 packet length	Length of packet available in F2 FIFO

gSPI Host-Device Handshake

To initiate communication through the gSPI after power-up, the host needs to bring up the WLAN chip by writing to the wake-up WLAN register bit. Writing a 1 to this bit will start up the necessary crystals and PLLs so that the BCM43364 is ready for data transfer. The device can signal an interrupt to the host indicating that the device is awake and ready. This procedure also needs to be followed for waking up the device in sleep mode. The device can interrupt the host using the WLAN IRQ line whenever it has any information to pass to the host. On getting an interrupt, the host needs to read the interrupt and/or status register to determine the cause of the interrupt and then take necessary actions.

Boot-Up Sequence

After power-up, the gSPI host needs to wait 50 ms for the device to be out of reset. For this, the host needs to poll with a read command to F0 address 0x14. Address 0x14 contains a predefined bit pattern. As soon as the host gets a response back with the correct register content, it implies that the device has powered up and is out of reset. After that, the host needs to set the wake-up WLAN bit (F0 reg 0x00 bit 7). Wake-up WLAN turns the PLL on; however, the PLL doesn't lock until the host programs the PLL registers to set the crystal frequency.

For the first time after power-up, the host needs to wait for the availability of the low-power clock inside the device. Once it is available, the host needs to write to a PMU register to set the crystal frequency. This will turn on the PLL. After the PLL is locked, the chipActive interrupt is issued to the host. This indicates device awake/ ready status. See Table 6 for information on gSPI registers.

In Table 6, the following notation is used for register access:

- R: Readable from host and CPU
- · W: Writable from host
- · U: Writable from CPU

Table 6: gSPI Registers

Address	Register	Bit	Access	Default	Description
x0000	Word length	0	R/W/U	0	0: 16-bit word length
					1: 32-bit word length
	Endianess	1	R/W/U	0	0: Little endian
					1: Big endian
	High-speed mode	4	R/W/U	1	0: Normal mode. Sample on SPICLK rising edge, output on falling edge.
					1: High-speed mode. Sample and output on rising edge of SPICLK (default).
	Interrupt polarity	5	R/W/U	1	0: Interrupt active polarity is low.
					1: Interrupt active polarity is high (default).
	Wake-up	7	R/W	0	A write of 1 denotes a wake-up command from host to device. This will be followed by an F2 interrupt from the gSPI device to host, indicating device awake status.

Table 6: gSPI Registers (Cont.)

Address	Register	Bit	Access	Default	Description
x0002	Status enable	0	R/W	1	0: No status sent to host after a read/write.
					1: Status sent to host after a read/write.
	Interrupt with status	1	R/W	0	0: Do not interrupt if status is sent.
					1: Interrupt host even if status is sent.
x0003	Reserved	_	_	_	-
x0004	Interrupt register	0	R/W	0	Requested data not available. Cleared by writing a 1 to this location.
		1	R	0	F2/F3 FIFO underflow from the last read.
		2	R	0	F2/F3 FIFO overflow from the last write.
		5	R	0	F2 packet available
		6	R	0	F3 packet available
		7	R	0	F1 overflow from the last write.
x0005	Interrupt register	5	R	0	F1 Interrupt
		6	R	0	F2 Interrupt
		7	R	0	F3 Interrupt
x0006, x0007	Interrupt enable register	15:0	R/W/U	16'hE0E7	Particular interrupt is enabled if a corresponding bit is set.
x0008 to x000B	Status register	31:0	R	32'h0000	Same as status bit definitions
x000C,	F1 info. register	0	R	1	F1 enabled
x000D		1	R	0	F1 ready for data transfer
		13:2	R/U	12'h40	F1 maximum packet size
x000E,	F2 info. register	0	R/U	1	F2 enabled
x000F		1	R	0	F2 ready for data transfer
		15:2	R/U	14'h800	F2 maximum packet size
x0014 to x0017	Test Read-only register	31:0	R	32'hFEEDB EAD	This register contains a predefined pattern, which the host can read to determine if the gSPI interface is working properly.
x0018 to x001B	Test R/W register	31:0	R/W/U	32'h000000 00	This is a dummy register where the host can write some pattern and read it back to determine if the gSPI interface is working properly.
x001C to x001F	Response delay registers	7:0	R/W	0x1D = 4, other registers = 0	Individual response delays for F0, F1, F2, and F3. The value of the registers is the number of byte delays that are introduced before data is shifted out of the gSPI interface during host reads.

Figure 15 on page 31 shows the WLAN boot-up sequence from power-up to firmware download, including the initial device power-on reset (POR) evoked by the WL_REG_ON signal. After initial power-up, the WL_REG_ON signal can be held low to disable the BCM43364 or pulsed low to induce a subsequent reset.



Note: The BCM43364 has an internal power-on reset (POR) circuit. The device will be held in reset for a maximum of 3 ms after VDDC and VDDIO have both passed the 0.6V threshold.

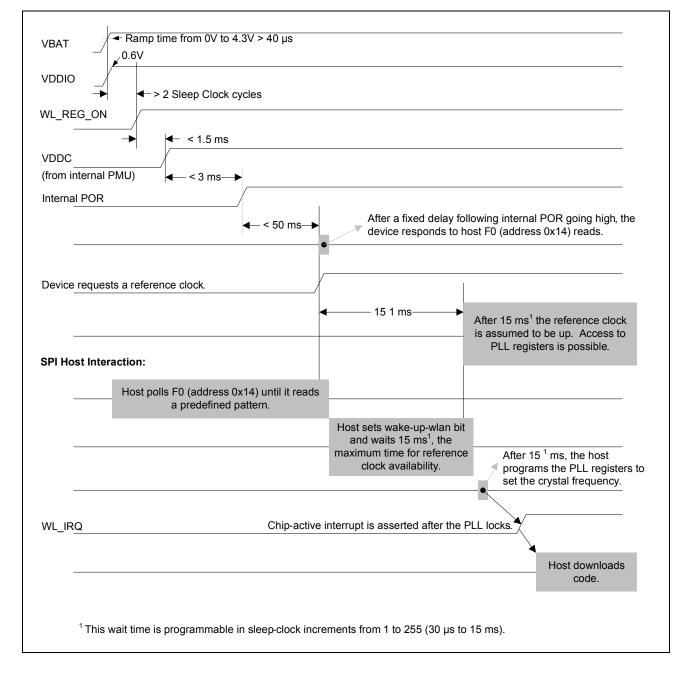


Figure 15: WLAN Boot-Up Sequence

Section 5: Wireless LAN MAC and PHY

MAC Features

The BCM43364 WLAN MAC supports features specified in the IEEE 802.11 base standard, and amended by IEEE 802.11n. The salient features are listed below:

- Transmission and reception of aggregated MPDUs (A-MPDU).
- Support for power management schemes, including WMM power-save, power-save multipoll (PSMP) and multiphase PSMP operation.
- Support for immediate ACK and Block-ACK policies.
- Interframe space timing support, including RIFS.
- Support for RTS/CTS and CTS-to-self frame sequences for protecting frame exchanges.
- Back-off counters in hardware for supporting multiple priorities as specified in the WMM specification.
- Timing synchronization function (TSF), network allocation vector (NAV) maintenance, and target beacon transmission time (TBTT) generation in hardware.
- Hardware off-load for AES-CCMP, legacy WPA TKIP, legacy WEP ciphers, WAPI, and support for key management.
- Programmable independent basic service set (IBSS) or infrastructure basic service set functionality
- Statistics counters for MIB support.

MAC Description

The BCM43364 WLAN MAC is designed to support high throughput operation with low-power consumption. In addition, several power-saving modes that have been implemented allow the MAC to consume very little power while maintaining network-wide timing synchronization. The architecture diagram of the MAC is shown in Figure 16 on page 33.

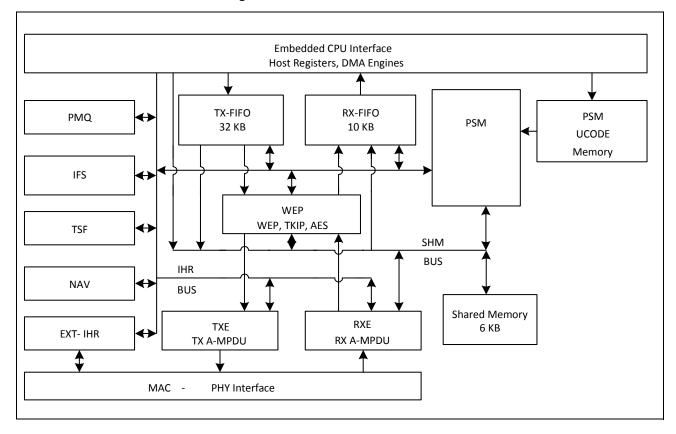


Figure 16: WLAN MAC Architecture

The following sections provide an overview of the important modules in the MAC.

PSM

The programmable state machine (PSM) is a microcoded engine that provides most of the low-level control to the hardware to implement the IEEE 802.11 specification. It is a microcontroller that is highly optimized for flow-control operations, which are predominant in implementations of communication protocols. The instruction set and fundamental operations are simple and general, which allows algorithms to be optimized until very late in the design process. It also allows for changes to the algorithms to track evolving IEEE 802.11 specifications.

The PSM fetches instructions from the microcode memory. It uses the shared memory to obtain operands for instructions, as a data store, and to exchange data between both the host and the MAC data pipeline (via the SHM bus). The PSM also uses a scratch-pad memory (similar to a register bank) to store frequently accessed and temporary variables.

The PSM exercises fine-grained control over the hardware engines by programming internal hardware registers (IHR). These IHRs are collocated with the hardware functions they control and are accessed by the PSM via the IHR bus.

The PSM fetches instructions from the microcode memory using an address determined by the program counter, an instruction literal, or a program stack. For ALU operations, the operands are obtained from shared memory, scratch-pad memory, IHRs, or instruction literals, and the results are written into the shared memory, scratch-pad memory, or IHRs.

There are two basic branch instructions: conditional branches and ALU-based branches. To better support the many decision points in the IEEE 802.11 algorithms, branches can depend on either readily available signals from the hardware modules (branch condition signals are available to the PSM without polling the IHRs) or on the results of ALU operations.

WEP

The wired equivalent privacy (WEP) engine encapsulates all the hardware accelerators to perform the encryption and decryption, as well as the MIC computation and verification. The accelerators implement the following cipher algorithms: legacy WEP, WPA TKIP, and WPA2 AES-CCMP.

Based on the frame type and association information, the PSM determines the appropriate cipher algorithm to be used. It supplies the keys to the hardware engines from an on-chip key table. The WEP interfaces with the transmit engine (TXE) to encrypt and compute the MIC on transmit frames and the receive engine (RXE) to decrypt and verify the MIC on receive frames. WAPI is also supported.

TXE

The transmit engine (TXE) constitutes the transmit data path of the MAC. It coordinates the DMA engines to store the transmit frames in the TXFIFO. It interfaces with WEP module to encrypt frames and transfers the frames across the MAC-PHY interface at the appropriate time determined by the channel access mechanisms.

The data received from the DMA engines are stored in transmit FIFOs. The MAC supports multiple logical queues to support traffic streams that have different QoS priority requirements. The PSM uses the channel access information from the IFS module to schedule a queue from which the next frame is transmitted. Once the frame is scheduled, the TXE hardware transmits the frame based on a precise timing trigger received from the IFS module.

The TXE module also contains the hardware that allows the rapid assembly of MPDUs into an A-MPDU for transmission. The hardware module aggregates the encrypted MPDUs by adding appropriate headers and pad delimiters as needed.

RXE

The receive engine (RXE) constitutes the receive data path of the MAC. It interfaces with the DMA engine to drain the received frames from the RX FIFO. It transfers bytes across the MAC-PHY interface and interfaces with the WEP module to decrypt frames. The decrypted data is stored in the RX FIFO.

The RXE module contains programmable filters that are programmed by the PSM to accept or filter frames based on several criteria such as receiver address, BSSID, and certain frame types.

The RXE module also contains the hardware required to detect A-MPDUs, parse the headers of the containers, and disaggregate them into component MPDUS.

IFS

The IFS module contains the timers required to determine interframe space timing including RIFS timing. It also contains multiple back-off engines required to support prioritized access to the medium as specified by WMM.

The interframe spacing timers are triggered by the cessation of channel activity on the medium, as indicated by the PHY. These timers provide precise timing to the TXE to begin frame transmission. The TXE uses this information to send response frames or perform transmit frame-bursting (RIFS or SIFS separated, as within a TXOP).

The back-off engines (for each access category) monitor channel activity, in each slot duration, to determine whether to continue or pause the back-off counters. When the back-off counters reach 0, the TXE gets notified so that it may commence frame transmission. In the event of multiple back-off counters decrementing to 0 at the same time, the hardware resolves the conflict based on policies provided by the PSM.

The IFS module also incorporates hardware that allows the MAC to enter a low-power state when operating under the IEEE power-saving mode. In this mode, the MAC is in a suspended state with its clock turned off. A sleep timer, whose count value is initialized by the PSM, runs on a slow clock and determines the duration over which the MAC remains in this suspended state. Once the timer expires, the MAC is restored to its functional state. The PSM updates the TSF timer based on the sleep duration, ensuring that the TSF is synchronized to the network.

TSF

The timing synchronization function (TSF) module maintains the TSF timer of the MAC. It also maintains the target beacon transmission time (TBTT). The TSF timer hardware, under the control of the PSM, is capable of adopting timestamps received from beacon and probe response frames in order to maintain synchronization with the network.

The TSF module also generates trigger signals for events that are specified as offsets from the TSF timer, such as uplink and downlink transmission times used in PSMP.

NAV

The network allocation vector (NAV) timer module is responsible for maintaining the NAV information conveyed through the duration field of MAC frames. This ensures that the MAC complies with the protection mechanisms specified in the standard.

The hardware, under the control of the PSM, maintains the NAV timer and updates the timer appropriately based on received frames. This timing information is provided to the IFS module, which uses it as a virtual carrier-sense indication.

MAC-PHY Interface

The MAC-PHY interface consists of a data path interface to exchange RX/TX data from/to the PHY. In addition, there is a programming interface, which can be controlled either by the host or the PSM to configure and control the PHY.

PHY Description

The BCM43364 WLAN digital PHY is designed to comply with IEEE 802.11b/g/n single stream to provide wireless LAN connectivity supporting data rates from 1 Mbps to 96 Mbps for low-power, high-performance handheld applications.

The PHY has been designed to meet specification requirements in the presence of interference, radio nonlinearity, and impairments. It incorporates efficient implementations of the filters, FFT, and Viterbi decoder algorithms. Efficient algorithms have been designed to achieve maximum throughput and reliability, including algorithms for carrier sense/rejection, frequency/phase/timing acquisition and tracking, and channel estimation and tracking. The PHY receiver also contains a robust IEEE 802.11b demodulator. The PHY carrier sense has been tuned to provide high throughput for IEEE 802.11g/IEEE 802.11b hybrid networks.

PHY Features

- Supports the IEEE 802.11b/g/n single-stream standards.
- Supports explicit IEEE 802.11n transmit beamforming.
- · Supports optional Greenfield mode in TX and RX.
- Tx and Rx LDPC for improved range and power efficiency.
- Supports IEEE 802.11h/d for worldwide operation.
- Algorithms achieving low power, enhanced sensitivity, range, and reliability.
- Automatic gain control scheme for blocking and nonblocking application scenarios for cellular applications.
- Closed-loop transmit power control.
- Designed to meet FCC and other regulatory requirements.
- Support for 2.4 GHz Broadcom TurboQAM data rates and 20 MHz channel bandwidth.

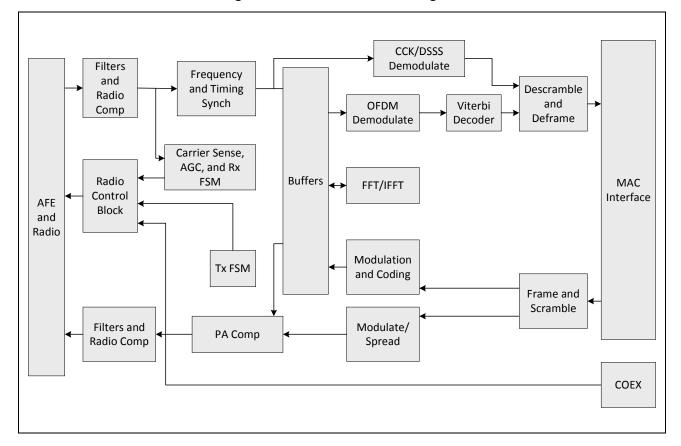


Figure 17: WLAN PHY Block Diagram

The PHY is capable of fully calibrating the RF front-end to extract the highest performance. On power-up, the PHY performs a full calibration suite to correct for IQ mismatch and local oscillator leakage. The PHY also performs periodic calibration to compensate for any temperature related drift, thus maintaining high-performance over time. A closed-loop transmit control algorithm maintains the output power at its required level and can control TX power on a per-packet basis.

Section 6: WLAN Radio Subsystem

The BCM43364 includes an integrated WLAN RF transceiver that has been optimized for use in 2.4 GHz Wireless LAN systems. It is designed to provide low power, low cost, and robust communications for applications operating in the globally available 2.4 GHz unlicensed ISM band. The transmit and receive sections include all on-chip filtering, mixing, and gain control functions. Improvements to the radio design include shared TX/RX baseband filters and high immunity to supply noise.

Figure 18 shows the radio functional block diagram.

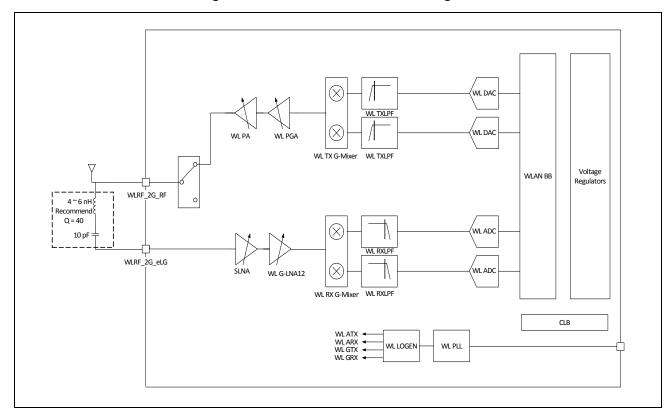


Figure 18: Radio Functional Block Diagram

Receive Path

The BCM43364 has a wide dynamic range, direct conversion receiver. It employs high-order on-chip channel filtering to ensure reliable operation in the noisy 2.4 GHz ISM band.

Transmit Path

Baseband data is modulated and upconverted to the 2.4 GHz ISM band. A linear on-chip power amplifier is included, which is capable of delivering high output powers while meeting IEEE 802.11b/g/n specifications without the need for an external PA. This PA is supplied by an internal LDO that is directly supplied by VBAT, thereby eliminating the need for a separate PALDO. Closed-loop output power control is integrated.

Calibration

The BCM43364 features dynamic on-chip calibration, eliminating process variation across components. This enables the BCM43364 to be used in high-volume applications because calibration routines are not required during manufacturing testing. These calibration routines are performed periodically during normal radio operation. Automatic calibration examples include baseband filter calibration for optimum transmit and receive performance and LOFT calibration for leakage reduction. In addition, I/Q calibration, R calibration, and VCO calibration are performed on-chip.

Section 7: CPU and Global Functions

WLAN CPU and Memory Subsystem

The BCM43364 includes an integrated ARM Cortex-M3 processor with internal RAM and ROM. The ARM Cortex-M3 processor is a low-power processor that features low gate count, low interrupt latency, and low-cost debugging. It is intended for deeply embedded applications that require fast interrupt response features. The processor implements the ARM architecture v7-M with support for the Thumb-2 instruction set. ARM Cortex-M3 provides a 30% performance gain over ARM7TDMI.

At 0.19 μ W/MHz, the Cortex-M3 is the most power efficient general purpose microprocessor available, outperforming 8- and 16-bit devices on MIPS/ μ W. It supports integrated sleep modes.

ARM Cortex-M3 uses multiple technologies to reduce cost through improved memory utilization, reduced pin overhead, and reduced silicon area. ARM Cortex-M3 supports independent buses for code and data access (ICode/DCode and system buses). ARM Cortex-M3 supports extensive debug features including real-time tracing of program execution.

On-chip memory for the CPU includes 512 KB SRAM and 640 KB ROM.

One-Time Programmable Memory

Various hardware configuration parameters may be stored in an internal 4096-bit One-Time Programmable (OTP) memory, which is read by system software after a device reset. In addition, customer-specific parameters, including the system vendor ID and the MAC address, can be stored, depending on the specific board design.

The initial state of all bits in an unprogrammed OTP device is 0. After any bit is programmed to a 1, it cannot be reprogrammed to 0. The entire OTP array can be programmed in a single write cycle using a utility provided with the Broadcom WLAN manufacturing test tools. Alternatively, multiple write cycles can be used to selectively program specific bytes, but only bits which are still in the 0 state can be altered during each programming cycle.

Prior to OTP memory programming, all values should be verified using the appropriate editable nvram.txt file, which is provided with the reference board design package. Documentation on the OTP development process is available on the Broadcom customer support portal (http://www.broadcom.com/support).

GPIO Interface

Five general-purpose I/O (GPIO) pins are available on the BCM43364 that can be used to connect to various external devices.

GPIOs are tristated by default. Subsequently, they can be programmed to be either input or output pins via the GPIO control register. They can also be programmed to have internal pull-up or pull-down resistors.

GPIO 0 is normally used as a WL HOST WAKE signal.

The BCM43364 supports 2-wire, 3-wire, and 4-wire coexistence configurations using GPIO_1 through GPIO_4. The signal functions of GPIO_1 through GPIO_4 are programmable to support the three coexistence configurations.

External Coexistence Interface

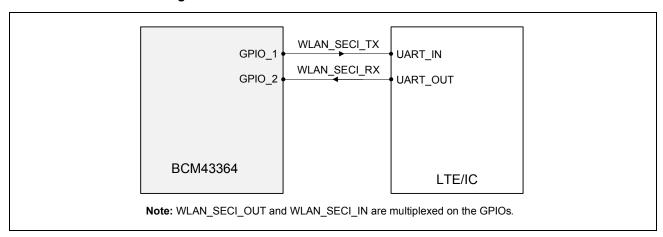
The BCM43364 supports 2-wire, 3-wire, and 4-wire coexistence interfaces to enable signaling between the device and an external colocated wireless device in order to manage wireless medium sharing for optimal performance. The external colocated device can be any of the following ICs: GPS, WiMAX, LTE, or UWB. An LTE IC is used in this section for illustration.

2-Wire Coexistence

Figure 19 shows a 2-wire LTE coexistence example. The following definitions apply to the GPIOs in the figure:

- GPIO_1: WLAN_SECI_TX output to an LTE IC.
- GPIO_2: WLAN_SECI_RX input from an LTE IC.

Figure 19: 2-Wire Coexistence Interface to an LTE IC



3-Wire and 4-Wire Coexistence Interfaces

Figure 20 and Figure 21 show 3-wire and 4-wire LTE coexistence examples, respectively. The following definitions apply to the GPIOs in the figures:

- For the 3-wire coexistence interface:
- GPIO_2: WLAN priority output to an LTE IC.
- GPIO_3: LTE_RX input from an LTE IC.
- GPIO_4: LTE_TX input from an LTE IC.

For the 4-wire coexistence interface:

- GPIO 1: WLAN priority output to an LTE IC.
- GPIO_2: LTE frame sync input from an LTE IC. This GPIO applies only to the 4-wire coexistence interface.
- GPIO_3: LTE_RX input from an LTE IC.
- GPIO_4: LTE_TX input from an LTE IC.

Figure 20: 3-Wire Coexistence Interface to an LTE IC

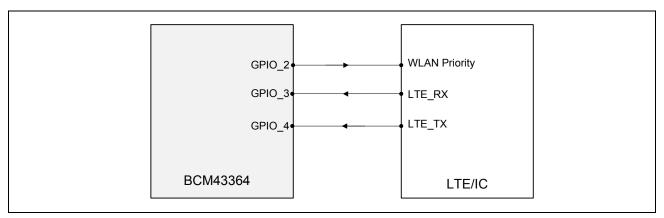
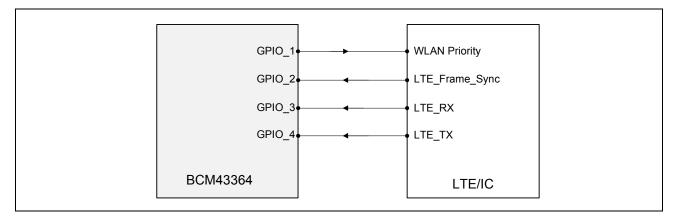


Figure 21: 4-Wire Coexistence Interface to an LTE IC



JTAG Interface

The BCM43364 supports the IEEE 1149.1 JTAG boundary scan standard over SDIO for performing device package and PCB assembly testing during manufacturing. In addition, the JTAG interface allows Broadcom to assist customers by using proprietary debug and characterization test tools during board bring-up. Therefore, it is highly recommended to provide access to the JTAG pins by means of test points or a header on all PCB designs.

UART Interface

One UART interface can be enabled by software as an alternate function on the JTAG pins. UART_RX is available on the JTAG_TDI pin, and UART_TX is available on the JTAG_TDO pin.

The UART is primarily for debugging during development. By adding an external RS-232 transceiver, this UART enables the BCM43364 to operate as RS-232 data termination equipment (DTE) for exchanging and managing data with other serial devices. It is compatible with the industry standard 16550 UART, and it provides a FIFO size of 64 × 8 in each direction.

Section 8: Pinout and Signal Descriptions

Ball Map

Figure 22 shows the 74-ball WLBGA ball map.

Figure 22: 74-Ball WLBGA Ball Map (Bottom View)

		Α	В	С	D	E	F	G	Н	J	К	L	М	
1	1	NC	NC	NC		NC	VDD_1P2	VDD_1P2	VDDB_PA	WLRF_2G_ eLG	WLRF_2G_ RF		WLRF_PA_ VDD	1
2	2	NC	NC	NC	NC	VDD_1P2	VDD_1P2	VSS	VSS	WLRF_LNA _GND	WLRF_GE NERAL_GN D	WLRF_PA_ GND	WLRF_VD D_ 1P35	2
3	3	NC	NC	NC	VDDC	VSS			VSS	WLRF_GPI O		WLRF_VC O_GND	WLRF_XTA L_ VDD1P2	3
4	4	NC	NC	NC	VSSC		NC	VDDC	WLRF_AFE _GND		GPIO_3	WLRF_XTA L_GND	WLRF_XTA L_XOP	4
5	5	NC	NC	SYS_VDDI O	NC	NC	LPO_IN	NC	NC	VSSC	GPIO_4	GPIO_2	WLRF_XTA L_XON	5
6	6	SR_VLX	PMU_AVS S	VOUT_CLD O	VOUT_LNL DO	GND	WCC_VDDI O	WL_REG_ ON	GPIO_1	GPIO_0	SDIO_DAT A_0	SDIO_CMD	CLK_REQ	6
7	7	SR_PVSS	SR_VDDB AT5V	LDO_VDD1 P5		VOUT_3P3	LDO_VDD BAT5V		SDIO_DAT A_1	SDIO_DAT A_3		SDIO_DAT A_2	SDIO_CLK	7
	Ī	Α	В	С	D	E	F	G	Н	J	К	L	М	

WLBGA Ball List in Ball Number Order with X-Y Coordinates

Table 7 provides ball numbers and names in ball number order. The table includes the X and Y coordinates for a top view with a (0,0) center.

Table 7: BCM43364 WLBGA Ball List — Ordered By Ball Number

Ball Number	Ball Name	X Coordinate	Y Coordinate
A1	NC	-1200.006	2199.996
A2	NC	-799.992	2199.996
A3	NC	-399.996	2199.996
A4	NC	0	2199.996
A5	NC	399.996	2199.996
A6	SR_VLX	799.992	2199.978
A7	SR_PVSS	1199.988	2199.978
B1	NC	-1200.006	1800
B2	NC	- 799.992	1800
B3	NC	-399.996	1800
B4	NC	0	1800
B5	NC	399.996	1800
B6	PMU_AVSS	799.992	1799.982
B7	SR_VBAT5V	1199.988	1799.982
C1	NC	-1200.006	1399.995
C2	NC	- 799.992	1399.986
C3	NC	-399.996	1399.995
C4	NC	0	1399.995
C5	SYS_VDDIO	399.996	1399.986
C6	VOUT_CLDO	799.992	1399.986
C7	LDO_VDD15V	1199.988	1399.986
D2	NC	– 799.992	999.99
D3	VDDC	-399.996	999.999
D4	VSSC	0	999.999
D5	NC	399.996	999.99
D6	VOUT_LNLDO	799.992	999.99
E1	NC	-1199.988	599.994
E2	VDD_1P2	-799.992	599.994
E3	VSS	-399.996	599.994
E5	NC	399.996	599.994
E6	GND	799.992	599.994
E7	VOUT_3P3	1199.988	599.994
F1	VDD_1P2	-1199.988	199.998

Table 7: BCM43364 WLBGA Ball List — Ordered By Ball Number

Ball Number	Ball Name	X Coordinate	Y Coordinate
F2	VDD_1P2	-799.992	199.998
F4	NC	0	199.998
F5	LPO_IN	399.996	199.998
F6	WCC_VDDIO	800.001	199.998
F7	LDO_VBAT5V	1199.988	199.998
G1	VDD_1P2	-1199.988	-199.998
G2	VSS	-799.992	-199.998
G4	VDDC	0	-199.998
G5	NC	399.996	-199.998
G6	WL_REG_ON	800.001	-199.998
H1	VDDB_PA	-1199.988	-599.994
H2	VSS	-799.992	-599.994
H3	VSS	-399.996	-599.994
H4	WLRF_AFE_GND	0	-599.994
H5	NC	399.996	-599.994
H6	GPIO_1	800.001	-599.994
H7	SDIO_DATA_1	1200.006	-599.994
J1	WLRF_2G_eLG	-1199.988	– 999.99
J2	WLRF_LNA_GND	-799.992	– 999.99
J3	WLRF_GPIO	-399.996	– 999.99
J5	VSSC	399.996	– 999.999
J6	GPIO_0	800.001	– 999.999
J7	SDIO_DATA_3	1200.006	– 999.999
K1	WLRF_2G_RF	-1199.988	-1399.986
K2	WLRF_GENERAL_GND	-799.992	-1399.986
K4	GPIO_3	0	-1399.995
K5	GPIO_4	399.996	-1399.995
K6	SDIO_DATA_0	800.001	-1399.995
L2	WLRF_PA_GND	-799.992	-1799.982
L3	WLRF_VCO_GND	-399.996	-1799.982
L4	WLRF_XTAL_GND	0	-1799.982
L5	GPIO_2	399.996	-1799.991
L6	SDIO_CMD	800.001	-1799.991
L7	SDIO_DATA_2	1200.006	-1799.991
M1	WLRF_PA_VDD	-1199.988	-2199.978
M2	WLRF_VDD_1P35	-799.992	-2199.978
M3	WLRF_XTAL_VDD1P2	-399.996	<i>–</i> 2199.978

Table 7: BCM43364 WLBGA Ball List — Ordered By Ball Number

Ball Number	Ball Name	X Coordinate	Y Coordinate
M4	WLRF_XTAL_XOP	0	-2199.978
M5	WLRF_XTAL_XON	399.996	-2199.978
M6	CLK_REQ	800.001	-2199.996
M7	SDIO_CLK	1200.006	-2199.996

WLBGA Ball List Ordered By Ball Name

Table 8 provides the ball numbers and names in ball name order.

Table 8: BCM43364 WLBGA Ball List — Ordered By Ball Name

Ball Name	Ball Number
CLK_REQ	M6
GND	E6
GPIO_0	J6
GPIO_1	H6
GPIO_2	L5
GPIO_3	K4
GPIO_4	K5
LDO_VDD1P5	C7
LDO_VDDBAT5V	F7
LPO_IN	F5
NC	A1
NC	A2
NC	A3
NC	A4
NC	A5
NC	B1
NC	B2
NC	B3
NC	B4
NC	B5
NC	C1
NC	C2
NC	C3
NC	C4
NC	D2
NC	D5
NC	E1
NC	E5
NC	F4
NC	G5
NC	H5
PMU_AVSS	B6
SDIO_CLK	M7
SDIO_CMD	L6
SDIO_DATA_0	K6
SDIO_DATA_1	H7
SDIO_DATA_2	L7

Ball Name	Ball Number
SDIO_DATA_3	J7
SR_PVSS	A7
SR_VDDBAT5V	B7
SR_VLX	A6
SYS_VDDIO	C5
VDD_1P2	E2
VDD_1P2	F1
VDD_1P2	F2
VDD_1P2	G1
VDDB_PA	H1
VDDC	D3
VDDC	G4
VOUT_3P3	E7
VOUT_CLDO	C6
VOUT_LNLDO	D6
VSS	E3
VSS	G2
VSS	H2
VSS	H3
VSSC	D4
VSSC	J5
WCC_VDDIO	F6
WL_REG_ON	G6
WLRF_2G_eLG	J1
WLRF_2G_RF	K1
WLRF_AFE_GND	H4
WLRF_GENERAL_GND	K2
WLRF_GPIO	J3
WLRF_LNA_GND	J2
WLRF_PA_GND	L2
WLRF_PA_VDD	M1
WLRF_VCO_GND	L3
WLRF_VDD_1P35	M2
WLRF_XTAL_GND	L4
WLRF_XTAL_VDD1P2	M3
WLRF_XTAL_XON	M5
WLRF_XTAL_XOP	M4

Signal Descriptions

Table 9 provides the WLBGA package signal descriptions.

Table 9: WLBGA Signal Descriptions

Signal Name	WLBGA Ball	Туре	Description
RF Signal Interface			
WLRF_2G_RF	K1	0	2.4 GHz WLAN RF output port.
SDIO Bus Interface			
SDIO_CLK	M7	I	SDIO clock input.
SDIO_CMD	L6	I/O	SDIO command line.
SDIO_DATA_0	K6	I/O	SDIO data line 0.
SDIO_DATA_1	H7	I/O	SDIO data line 1.
SDIO_DATA_2	L7	I/O	SDIO data line 2. Also used as a strapping option (see Table 12 on page 53).
SDIO_DATA_3	J7	I/O	SDIO data line 3.

Note: Per Section 6 of the SDIO specification, 10 to 100 k Ω pull-ups are required on the four DATA lines and the CMD line. This requirement must be met during all operating states by using external pull-up resistors or properly programming internal SDIO host pull-ups.

WLAN GPIO Interface			
WLRF_GPIO	J3	I/O	Test pin. Not connected in normal operation.
Clocks			
WLRF_XTAL_XON	M5	0	XTAL oscillator output.
WLRF_XTAL_XOP	M4	I	XTAL oscillator input.
CLK_REQ	M6	0	External system clock request—Used when the system clock is not provided by a dedicated crystal (for example, when a shared TCXO is used). Asserted to indicate to the host that the clock is required.
LPO_IN	F5	I	External sleep clock input (32.768 kHz). If an external 32.768 kHz clock cannot be provided, pull this pin low.
No Connect			
NC_A1	A1	I	No connect.
NC_A2	A2	0	No connect.
NC_A3	A3	I/O	No connect.

Table 9: WLBGA Signal Descriptions (Cont.)

Signal Name	WLBGA Ball	Type	Description
NC_A4	A4	I/O	No connect.
NC_A5	A5	I/O	No connect.
NC_B1	B1	I/O	No connect.
NC_B2	B2	I	No connect.
NC_B3	В3	I/O	No connect.
NC_B4	B4	0	No connect.
NC_B5	B5	I/O	No connect.
NC_C1	C1	I/O	No connect.
NC_C2	C2	0	No connect.
NC_C3	C3	0	No connect.
NC_C4	C4	I	No connect.
NC_D2	D2	0	No connect.
NC_E1	E1	I	No connect.
NC_F4	F4	I/O	No connect.
NC_G5	G5	I/O	No connect.
NC_H5	H5	I/O	No connect.
NC_E5	E5	N/A	Not used. Do not connect to this pin.
NC_D5	D5	N/A	Not used. Do not connect to this pin.
Miscellaneous			
WL_REG_ON	G6	I	Used by PMU to power up or power down the internal regulators used by the WLAN section. Also, when deasserted, this pin holds the WLAN section in reset. This pin has an internal 200 k Ω pull-down resistor that is enabled by default. It can be disabled through programming.
GND_E6	E6	I	Tie pin E6 to ground.
GPIO_0	J6	I/O	Programmable GPIO pins. This pin becomes an output pin when it is used as WLAN_HOST_WAKE/out-of-band signal.
GPIO_1	H6	I/O	Programmable GPIO pins.
GPIO_2	L5	I/O	Programmable GPIO pins.
GPIO_3	K4	I/O	Programmable GPIO pins.
GPIO_4	K5	I/O	Programmable GPIO pins.
WLRF_2G_eLG	J1	I	Connect to an external inductor. See the reference schematic for details.
Integrated Voltage Regulators	S		
SR_VDDBAT5V	B7	I	SR VBAT input power supply.
SR_VLX	A6	0	CBUCK switching regulator output. See Table 21 on page 65 for details of the inductor and capacitor required on this output.
LDO_VDDBAT5V	F7	I	LDO VBAT.
LDO VDD1P5	C7	I	LNLDO input.

Table 9: WLBGA Signal Descriptions (Cont.)

Signal Name	WLBGA Ball	Туре	Description
VOUT_LNLDO	D6	0	Output of low-noise LNLDO.
VOUT_CLDO	C6	0	Output of core LDO.
VDDB_PA	H1	I	Connect to VOUT_3P3.
VDD_1P2	G1	I	Connect to VOUT_LNLDO.
VDD_1P2	F2	I	Connect to VOUT_LNLDO.
VDD_1P2	F1	1	Connect to VOUT_LNLDO.
VDD_1P2	E2	I	Connect pin E2 to VOUT_LNLDO.
Power Supplies			
WLRF_XTAL_VDD1P2	M3	I	XTAL oscillator supply.
WLRF_PA_VDD	M1	1	Power amplifier supply.
WCC_VDDIO	F6	1	VDDIO input supply. Connect to VDDIO.
SYS_VDDIO	C5	I	VDDIO input supply. Connect to VDDIO.
WLRF_VDD_1P35	M2	I	LNLDO input supply.
VDDC	D3, G4	I	Core supply for WLAN.
VOUT_3P3	E7	0	3.3V output supply. See the reference schematic for details.
Ground			
VSS_H2	H2	I	Connect to ground.
VSS_G2	G2	I	Connect to ground.
VSS_H3	H3	I	Connect to ground.
VSS_E3	E3	I	Connect to ground.
PMU_AVSS	B6	I	Quiet ground.
SR_PVSS	A7	I	Switcher-power ground.
VSSC	D4, J5	I	Core ground for WLAN.
WLRF_AFE_GND	H4	I	AFE ground.
WLRF_LNA_GND	J2	I	2.4 GHz internal LNA ground.
WLRF_GENERAL_GND	K2	I	Miscellaneous RF ground.
WLRF_PA_GND	L2	I	2.4 GHz PA ground.
WLRF_VCO_GND	L3	I	VCO/LO generator ground.
WLRF_XTAL_GND	L4	I	XTAL ground.

WLAN GPIO Signals and Strapping Options

The pins listed in Table 10 are sampled at power-on reset (POR) to determine the various operating modes. Sampling occurs a few milliseconds after an internal POR or deassertion of the external POR. After the POR, each pin assumes the GPIO or alternative function specified in the signal descriptions table. Each strapping option pin has an internal pull-up (PU) or pull-down (PD) resistor that determines the default mode. To change the mode, connect an external PU resistor to VDDIO or a PD resistor to ground using a 10 k Ω resistor or less.



Note: Refer to the reference board schematics for more information.

Table 10: GPIO Functions and Strapping Options

Pin Name	WLBGA Pin #	# Default	Function	Description
SDIO_DATA_2	L7	1	WLAN host interface select	This pin selects the WLAN host interface mode. The default is SDIO. For gSPI, pull this pin low.

Chip Debug Options

The chip can be accessed for debugging via the JTAG interface, multiplexed on the SDIO_DATA_0 through SDIO_DATA_3 (and SDIO_CLK) I/O depending on the bootstrap state of GPIO_1 and GPIO_2.

Table 11 shows the debug options of the device.

Table 11: Chip Debug Options

JTAG_SEL	GPIO_2	GPIO_1	Function	SDIO I/O Pad Function
0	0	0	Normal mode	SDIO
0	0	1	JTAG over SDIO	JTAG
0	1	1	SWD over GPIO_1/GPIO_2	SDIO

BCM43364 Preliminary Data Sheet I/O States

I/O States

The following notations are used in Table 12:

- I: Input signal
- O: Output signal
- I/O: Input/Output signal
- PU = Pulled up
- PD = Pulled down
- NoPull = Neither pulled up nor pulled down

Table 12: I/O States

Name	1/0	Keeper	Active Mode	Low Power State/ Sleep (All Power Present)	Power-down (WL_REG_ON=0)	Out-of-Reset; (WL_REG_ON=1)	WL_REG_ON=1 and VDDIOs are Present		Power Rail
WL_REG_ON	I	N	Input; PD (pull-down can be disabled)	Input; PD (pull-down can be disabled)	Input; PD (of 200K)	Input; PD (200k)	Input; PD (200k)	-	-
CLK_REQ	I/O	Y	Open drain or push-pull (programmable). Active high.	Open drain or push-pull (programmable). Active high	PD	Open drain, active high.	Open drain, active high.	Open drain, active high.	WCC_VDDIO
SDIO_DATA_0	I/O	N	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> PU	SDIO MODE -> NoPull	Input; PU	WCC_VDDIO
SDIO_DATA_1	I/O	N	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> PU	SDIO MODE -> NoPull	Input; PU	WCC_VDDIO
SDIO_DATA_2	I/O	N	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> PU	SDIO MODE -> NoPull	Input; PU	WCC_VDDIO
SDIO_DATA_3	I/O	N	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> PU	SDIO MODE -> NoPull	Input; PU	WCC_VDDIO
SDIO_CMD	I/O	N	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> PU	SDIO MODE -> NoPull	Input; PU	WCC_VDDIO
SDIO_CLK	I	N	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	SDIO MODE -> NoPull	Input	WCC_VDDIO
JTAG_SEL	I	Υ	PD	PD	High-Z, NoPull	Input, PD	PD	Input, PD	WCC_VDDIO
GPIO_0	I/O	Υ	TBD	Active mode	High-Z, NoPull ^a	Input, SDIO OOB Int, NoPull	Active mode	Input, NoPull	WCC_VDDIO
GPIO_1	I/O	Υ	TBD	Active mode	High-Z, NoPull ^a	Input, PD	Active mode	Input, Strap, PD	WCC_VDDIO
GPIO_2	I/O	Y	TBD	Active mode	High-Z, NoPull ^a	Input, GCI GPIO[7], NoPull	Active mode	Input, Strap, NoPull	WCC_VDDIO

BCM43364 Preliminary Data Sheet I/O States

Table 12: I/O States (Cont.)

Name	1/0	Keeper	Active Mode	Low Power State/ Sleep (All Power Present)	Power-down (WL_REG_ON=0)		WL_REG_ON=1 and VDDIOs are Present		Power Rail
GPIO_3	I/O	Υ	TBD	Active mode	High-Z, NoPull ^a	Input, GCI GPIO[0], PU	Active mode	Input, PU	WCC_VDDIO
GPIO_4	I/O	Υ	TBD	Active mode	High-Z, NoPull ^a	Input, GCI GPIO[1], PU	Active mode	Input, PU	WCC_VDDIO

Note:

- 1. Keeper column: N = pad has no keeper. Y = pad has a keeper. Keeper is always active except in the Power-down state.
- 2. If there is no keeper, and it is an input and there is Nopull, then the pad should be driven to prevent leakage due to a floating pad (e.g., SDIO CLK).
- 3. In the Power-down state (xx REG ON = 0): High-Z; NoPull => The pad is disabled because power is not supplied.
- 4. Depending on whether the PCM interface is enabled and the configuration is master or slave mode, it can be either an output or input.
- 5. Depending on whether the I²S interface is enabled and the configuration is master or slave mode, it can be either an output or input.
- 6. The GPIO pull states for the Active and Low-Power states are hardware defaults. They can all be subsequently programmed as pull-ups or pull-downs.
- 7. Regarding GPIO pins, the following are the pull-up and pull-down values for both 3.3V and 1.8V VDDIO:

	Minimum (kΩ)	Typical (kΩ)	Maximum (kΩ)
3.3V VDDIO pull-downs:	51.5	44.5	38
3.3V VDDIO pull-ups:	37.4	39.5	44.5
1.8V VDDIO pull-downs:	64	83	116
1.8V VDDIO pull-ups:	65	86	118

a. The GPIO pull states for the active and low-power states are hardware defaults. They can all be subsequently programmed as a pull-up or pull-down.

Section 9: DC Characteristics



Note: Values in this data sheet are design goals and are subject to change based on the results of device characterization.

Absolute Maximum Ratings



Caution! The absolute maximum ratings in Table 13 indicate levels where permanent damage to the device can occur, even if these limits are exceeded for only a brief duration. Functional operation is not guaranteed under these conditions. Excluding VBAT, operation at the absolute maximum conditions for extended periods can adversely affect long-term reliability of the device.

Table 13: Absolute Maximum Ratings

Rating	Symbol	Value	Unit
DC supply for VBAT and PA driver supply	VBAT	-0.5 to +6.0 ^a	V
DC supply voltage for digital I/O	VDDIO	-0.5 to 3.9	V
DC supply voltage for RF switch I/Os	VDDIO_RF	-0.5 to 3.9	V
DC input supply voltage for CLDO and LNLDO	_	-0.5 to 1.575	V
DC supply voltage for RF analog	VDDRF	-0.5 to 1.32	V
DC supply voltage for core	VDDC	-0.5 to 1.32	V
Maximum undershoot voltage for I/O ^b	V _{undershoot}	-0.5	V
Maximum overshoot voltage for I/Ob	V _{overshoot}	VDDIO + 0.5	V
Maximum junction temperature	T _j	125	°C

a. Continuous operation at 6.0V is supported.

b. Duration not to exceed 25% of the duty cycle.

Environmental Ratings

The environmental ratings are shown in Table 14.

Table 14: Environmental Ratings

Characteristic	Value	Units	Conditions/Comments
Ambient temperature (T _A)	−30 to +70°C ^a	°C	Operation
Storage temperature	–40 to +125°C	°C	-
Relative humidity	Less than 60	%	Storage
	Less than 85	%	Operation

a. Functionality is guaranteed, but specifications require derating at extreme temperatures (see the specification tables for details).

Electrostatic Discharge Specifications

Extreme caution must be exercised to prevent electrostatic discharge (ESD) damage. Proper use of wrist and heel grounding straps to discharge static electricity is required when handling these devices. Always store unused material in its antistatic packaging.

Table 15: ESD Specifications

Pin Type	Symbol	Condition	ESD Rating	Unit
ESD, Handling Reference: NQY00083, Section 3.4, Group D9, Table B	ESD_HAND_HBM	Human Body Model Contact Discharge per JEDEC EID/ JESD22-A114	1250	V
Machine Model (MM)	ESD_HAND_MM	Machine Model Contact	50	V
CDM	ESD_HAND_CDM	Charged Device Model Contact Discharge per JEDEC EIA/ JESD22-C101	300	V

Recommended Operating Conditions and DC Characteristics

Functional operation is not guaranteed outside the limits shown in Table 16, and operation outside these limits for extended periods can adversely affect long-term reliability of the device.

Table 16: Recommended Operating Conditions and DC Characteristics

		Value			
Element	Symbol	Minimum	Typical	Maximum	Unit
DC supply voltage for VBAT	VBAT	3.0 ^a	_	4.8 ^b	V
DC supply voltage for core	VDD	1.14	1.2	1.26	V
DC supply voltage for RF blocks in chip	VDDRF	1.14	1.2	1.26	V

Table 16: Recommended Operating Conditions and DC Characteristics (Cont.)

			Value		
Element	Symbol	Minimum	Typical	Maximum	_ Unit
DC supply voltage for digital I/O	VDDIO, VDDIO_SD	1.71	_	3.63	V
DC supply voltage for RF switch I/Os	VDDIO_RF	3.13	3.3	3.46	V
External TSSI input	TSSI	0.15	_	0.95	V
Internal POR threshold	Vth_POR	0.4	_	0.7	V
SDIO Interface I/O Pins					
For VDDIO_SD = 1.8V:					
Input high voltage	VIH	1.27	_	_	V
Input low voltage	VIL	_	_	0.58	V
Output high voltage @ 2 mA	VOH	1.40	_	_	V
Output low voltage @ 2 mA	VOL	_	_	0.45	V
For VDDIO_SD = 3.3V:					
Input high voltage	VIH	0.625 × VDDIC	_	_	V
Input low voltage	VIL		_	0.25 × VDDIO	V
Output high voltage @ 2 mA	VOH	0.75 × VDDIO	_		V
Output low voltage @ 2 mA	VOL		_	0.125 × VDDIO	V
Other Digital I/O Pins					
For VDDIO = 1.8V:					
Input high voltage	VIH	0.65 × VDDIO	_	_	V
Input low voltage	VIL	_	_	0.35 × VDDIO	V
Output high voltage @ 2 mA	VOH	VDDIO - 0.45	_	_	V
Output low voltage @ 2 mA	VOL	_	_	0.45	V
For VDDIO = 3.3V:		 -		 -	
Input high voltage	VIH	2.00	_	_	V
Input low voltage	VIL	_	_	0.80	V
Output high voltage @ 2 mA	VOH	VDDIO – 0.4	_	_	V
Output low Voltage @ 2 mA	VOL	_	_	0.40	V
RF Switch Control Output Pins ^c					
For VDDIO_RF = 3.3V:					
Output high voltage @ 2 mA	VOH	VDDIO – 0.4	_	_	V
Output low voltage @ 2 mA	VOL	_	_	0.40	V
Input capacitance	C _{IN}	_	_	5	pF

a. The BCM43364 is functional across this range of voltages. However, optimal RF performance specified in the data sheet is guaranteed only for 3.2V < VBAT < 4.8V.

b. The maximum continuous voltage is 4.8V. Voltages up to 6.0V for up to 10 seconds, cumulative duration over the lifetime of the device are allowed. Voltages as high as 5.0V for up to 250 seconds, cumulative duration over the lifetime of the device are allowed.

c. Programmable 2 mA to 16 mA drive strength. Default is 10 mA.

Section 10: WLAN RF Specifications

The BCM43364 includes an integrated direct conversion radio that supports the 2.4 GHz band. This section describes the RF characteristics of the 2.4 GHz radio.



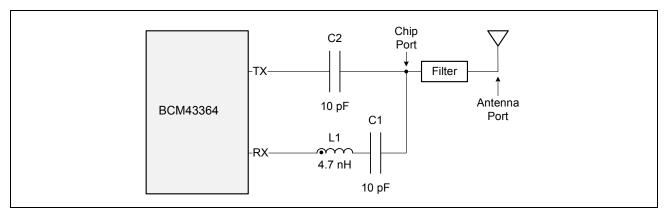
Note: Values in this data sheet are design goals and may change based on device characterization results.

Unless otherwise stated, the specifications in this section apply when the operating conditions are within the limits specified in Table 14: "Environmental Ratings," on page 56 and Table 16: "Recommended Operating Conditions and DC Characteristics," on page 56. Functional operation outside these limits is not guaranteed.

Typical values apply for the following conditions:

- VBAT = 3.6V.
- · Ambient temperature +25°C.

Figure 23: RF Port Location





Note: All specifications apply at the chip port unless otherwise specified.

2.4 GHz Band General RF Specifications

Table 17: 2.4 GHz Band General RF Specifications

Item	Condition	Minimum	Typical	Maximum	Unit
TX/RX switch time	Including TX ramp down	_	_	5	μs
RX/TX switch time	Including TX ramp up	_	_	2	μs

WLAN 2.4 GHz Receiver Performance Specifications



Note: Unless otherwise specified, the specifications in Table 18 are measured at the chip port (for the location of the chip port, see Figure 23 on page 58).

Table 18: WLAN 2.4 GHz Receiver Performance Specifications

Parameter	Condition/Notes	Minimum	Typical	Maximum	Unit			
Frequency range	-	2400	_	2500	MHz			
RX sensitivity (8% PER for	1 Mbps DSSS	- 97.5	-99.5	_	dBm			
1024 octet PSDU) ^a	2 Mbps DSSS	-93.5	-95.5	_	dBm			
	5.5 Mbps DSSS	- 91.5	-93.5	_	dBm			
	11 Mbps DSSS	-88.5	-90.5	_	dBm			
RX sensitivity (10% PER for		- 91.5	-93.5	_	dBm			
1000 octet PSDU) at WLAN	9 Mbps OFDM	-90.5	-92.5	_	dBm			
RF port ^a	12 Mbps OFDM	– 87.5	-89.5	_	dBm			
	18 Mbps OFDM	-85.5	- 87.5	_	dBm			
	24 Mbps OFDM	-82.5	-84.5	_	dBm			
	36 Mbps OFDM	-80.5	-82.5	_	dBm			
	48 Mbps OFDM	- 76.5	-78.5	_	dBm			
	54 Mbps OFDM	- 75.5	-77.5	_	dBm			
RX sensitivity	20 MHz channel spacing for all MCS rates (Mixed mode)							
(10% PER for 4096 octet	256-QAM, R = 5/6	– 67.5	-69.5	_	dBm			
PSDU). Defined for default parameters: GF, 800 ns GI.	256-QAM, R = 3/4	-69.5	- 71.5	_	dBm			
parameters. Or, ood no Or.	MCS7	– 71.5	-73.5	_	dBm			
	MCS6	- 73.5	- 75.5	_	dBm			
	MCS5	-74.5	-76.5	_	dBm			
	MCS4	- 79.5	- 81.5	_	dBm			
	MCS3	-82.5	-84.5	_	dBm			
	MCS2	-84.5	-86.5	_	dBm			
	MCS1	-86.5	-88.5	_	dBm			
	MCS0	-90.5	-92.5	_	dBm			

Table 18: WLAN 2.4 GHz Receiver Performance Specifications (Cont.)

Parameter	Condi	ition/Notes	Minimum	Typical	Maximum	Unit
Blocking level for 3 dB Rx sensitivity degradation	704–716	LTE	_	–13	_	dBm
sensitivity degradation (without external filtering)	777–787	LTE	_	-13	_	dBm
(without external liftering)	776–794 MHz	CDMA2000	_	-13.5	_	dBm
	815–830	LTE	_	-12.5	_	dBm
	816–824	CDMA2000	_	-13.5	_	dBm
	816–849	LTE	_	-11.5	_	dBm
	824–849	WCDMA	_	-11.5	_	dBm
	824–849	CDMA2000	-	-12.5	_	dBm
	824–849	LTE	_	-11.5	_	dBm
	824–849	GSM850	_	-8	_	dBm
	830–845	LTE	_	-11.5	_	dBm
	832–862	LTE	-	–11.5	_	dBm
	880–915	WCDMA	-	–10	_	dBm
	880–915	LTE	_	-12	_	dBm
	880–915	E-GSM	_	– 9	_	dBm
	1710–1755	WCDMA	_	–13	_	dBm
	1710–1755	LTE	_	-14.5	_	dBm
	1710–1755	CDMA2000	_	-14.5	_	dBm
	1710–1785	WCDMA	_	–13	_	dBm
	1710–1785	LTE	_	-14.5	_	dBm
	1710–1785	GSM1800	_	-12.5	_	dBm
	1850–1910	GSM1900	_	–11.5	_	dBm
	1850–1910	CDMA2000	_	–16	_	dBm
	1850–1910	WCDMA	_	-13.5	_	dBm
	1850–1910	LTE	_	–16	_	dBm
	1850–1915	LTE	_	–17	_	dBm
	1920–1980	WCDMA	_	–17.5	_	dBm
Blocking level for 3 dB Rx	1920–1980	CDMA2000	_	-19.5	_	dBm
sensitivity degradation (without external filtering)	1920–1980	LTE	_	– 19.5	_	dBm
(cont.)	2300–2400	LTE	_	–44	_	dBm
(001111)	2500–2570	LTE	_	–43	_	dBm
	2570–2620	LTE	_	-34	_	dBm
	5G (WLAN)	WLAN	_	>-4	_	dBm
Maximum receive level	@ 1, 2 Mbps (8%	% PER, 1024 octets)	- 6	_	_	dBm
@ 2.4 GHz	@ 5.5, 11 Mbps octets)	(8% PER, 1024	–12	-	-	dBm
	@ 6–54 Mbps (1 octets)	10% PER, 1000	-15.5		_	dBm

Table 18: WLAN 2.4 GHz Receiver Performance Specifications (Cont.)

Parameter	Conditi	ion/Notes	Minimum	Typical	Maximum	Unit
Adjacent channel rejection-DSSS.	11 Mbps DSSS	–70 dBm	35	-	-	dB
(Difference between interfering and desired signal [25 MHz apart] at 8% PER for 1024 octet PSDU with desired signal level as specified in Condition/ Notes.)						
Adjacent channel rejection-	6 Mbps OFDM	–79 dBm	16	_	_	dB
OFDM.	9 Mbps OFDM	–78 dBm	15	_	_	dB
(Difference between interfering and desired	12 Mbps OFDM	–76 dBm	13	_	_	dB
signal (25 MHz apart) at	18 Mbps OFDM	–74 dBm	11	_	_	dB
10% PER for 1000 ^b octet	24 Mbps OFDM	–71 dBm	8	_	_	dB
PSDU with desired signal	36 Mbps OFDM	–67 dBm	4	_	_	dB
level as specified in Condition/Notes.)	48 Mbps OFDM	–63 dBm	0	_	_	dB
	54 Mbps OFDM	–62 dBm	-1	_	_	dB
	65 Mbps OFDM	–61 dBm	-2	_	_	dB
RCPI accuracy ^c	Range –98 dBm t	o –75 dBm	-3	_	3	dB
 	Range above –75	dBm	- 5	_	5	dB
Return loss	Zo = 50Ω across	the dynamic range.	10	_	_	dB

a. Optimal RF performance, as specified in this data sheet, is guaranteed only for temperatures between -10° C and 55° C.

b. For 65 Mbps, the size is 4096.

c. The minimum and maximum values shown have a 95% confidence level.

WLAN 2.4 GHz Transmitter Performance Specifications



Note: Unless otherwise specified, the specifications in Table 18 are measured at the chip port (for the location of the chip port, see Figure 23 on page 58).

Table 19: WLAN 2.4 GHz Transmitter Performance Specifications

Parameter	Cond	lition/Notes	Minimum	Typical	Maximum	Unit
Frequency range	_		2400	_	2500	MHz
Transmitted power in	776–794 MHz	CDMA2000	_	-167.5	_	dBm/Hz
cellular and WLAN 5G band (at 21 dBm, 90% duty	869–960 MHz	CDMAOne, GSM850	_	-163.5	_	dBm/Hz
cycle, 1 Mbps CCK).	1450–1495	DAB	_	-154.5	_	dBm/Hz
, , , ,	1570–1580 MHz	GPS	_	-152.5	_	dBm/Hz
	1592–1610 MHz	GLONASS	_	-149.5	_	dBm/Hz
	1710–1800	DSC-1800-Uplink	_	-145.5	_	dBm/Hz
	1805–1880 MHz	GSM 1800	_	-143.5	_	dBm/Hz
	1850–1910 MHz	GSM 1900	_	-140.5	_	dBm/Hz
	1910–1930 MHz	TDSCDMA,LTE	_	-138.5	_	dBm/Hz
	1930–1990 MHz	GSM1900, CDMAOne, WCDMA	-	-139	_	dBm/Hz
	2010–2075 MHz	TDSCDMA	_	-127.5	_	dBm/Hz
	2110–2170 MHz	WCDMA	_	-124.5	_	dBm/Hz
	2305–2370	LTE Band 40	_	-104.5	_	dBm/Hz
	2370–2400	LTE Band 40	_	-81.5	_	dBm/Hz
	2496–2530	LTE Band 41	_	-94.5	_	dBm/Hz
	2530–2560	LTE Band 41	_	-120.5	_	dBm/Hz
	2570–2690	LTE Band 41	_	-121.5	_	dBm/Hz
	5000–5900	WLAN 5G	_	-109.5	_	dBm/Hz
Harmonic level (at 21 dBm with 90% duty cycle, 1 Mbps CCK)	4.8-5.0 GHz	2nd Harmonic	_	-26.5	_	dBm/ MHz
	7.2-7.5 GHz	3rd Harmonic	-	-23.5	-	dBm/ MHz
	9.6-10 GHz	4th Harmonic	_	-32.5	_	dBm/ MHz

Table 19: WLAN 2.4 GHz Transmitter Performance Specifications (Cont.)

Parameter	Cond	Condition/Notes		Typical	Maximum	Unit
TX power at the chip port	EVM Does Not E	xceed				
for the highest power level setting at 25°C, VBA = 3.6V, and spectral	IEEE 802.11b (DSSS/CCK)	−9 dB	21	_	_	dBm
mask and EVM	OFDM, BPSK	–8 dB	20.5	_	_	dBm
compliance ^{a, b}	OFDM, QPSK	–13 dB	20.5	_	_	dBm
	OFDM, 16-QAM	–19 dB	20.5	_	_	dBm
	OFDM, 64-QAM (R = 3/4)	–25 dB	18	-	_	dBm
	OFDM, 64-QAM (R = 5/6)	–27 dB	17.5	-	_	dBm
	OFDM, 256-QAM (R = 5/6)	−32 dB	15	-	-	dBm
TX power control dynamic range	_	-			_	dB
Closed loop TX power variation at highest power level setting		rature and voltage ross 5 to 21 dBm output	_	-	±1.5	dB
Carrier suppression	_		15	_	_	dBc
Gain control step	_		_	0.25	_	dB
Return loss	Zo = 50		4	6	_	dB
Load pull variation for	VSWR = 2:1.	EVM degradation	_	3.5	_	dB
output power, EVM, and Adjacent Channel Power		Output power variation	_	±2	_	dB
Ratio (ACPR)		ACPR-compliant power level	_	15	_	dBm
	VSWR = 3:1.	EVM degradation	_	4	_	dB
		Output power variation	_	±3	_	dB
		ACPR-compliant power level	-	15	-	dBm

a. TX power for channel 1 and channel 11 is specified separately by nonvolatile memory parameters to ensure band-edge compliance.

b. Optimal RF performance, as specified in this data sheet, is guaranteed only for temperatures between -10°C and 55°C.

General Spurious Emissions Specifications

Table 20: General Spurious Emissions Specifications

Parameter	Condition/Notes		Minimum	Typical	Maximum	Unit			
Frequency range	_		2400	_	2500	MHz			
General Spurious	Emissions								
TX emissions	30 MHz < f < 1 GHz	RBW = 100 kHz	_	-99	- 96	dBm			
	1 GHz < f < 12.75 GHz	RBW = 1 MHz	_	-44	-4 1	dBm			
	1.8 GHz < f < 1.9 GHz	RBW = 1 MHz	_	-68	– 65	dBm			
	5.15 GHz < f < 5.3 GHz	RBW = 1 MHz	_	-88	– 85	dBm			
RX/standby	30 MHz < f < 1 GHz	RBW = 100 kHz	_	-99	- 96	dBm			
emissions	1 GHz < f < 12.75 GHz	RBW = 1 MHz	_	-54	– 51	dBm			
	1.8 GHz < f < 1.9 GHz	RBW = 1 MHz	_	-88	- 85	dBm			
	5.15 GHz < f < 5.3 GHz	RBW = 1 MHz	_	-88	-85	dBm			
Note: The specific	Note: The specifications in this table apply at the chip port.								

Section 11: Internal Regulator Electrical Specifications



Note: Values in this data sheet are design goals and are subject to change based on device characterization results.

Functional operation is not guaranteed outside of the specification limits provided in this section.

Core Buck Switching Regulator

Table 21: Core Buck Switching Regulator (CBUCK) Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage (DC)	DC voltage range inclusive of disturbances.	2.4	3.6	4.8 ^a	V
PWM mode switching frequency	CCM, load > 100 mA VBAT = 3.6V.	-	4	-	MHz
PWM output current	-	_	_	370	mA
Output current limit	-	_	1400	_	mA
Output voltage range	Programmable, 30 mV steps. Default = 1.35V.	1.2	1.35	1.5	V
PWM output voltage DC accuracy	Includes load and line regulation. Forced PWM mode.	-4	_	4	%
PWM ripple voltage, static	Measure with 20 MHz bandwidth limit.	_	7	20	mVpp
	Static load, max. ripple based on VBAT = 3.6V, Vout = 1.35V, Fsw = 4 MHz, 2.2 μ H inductor L > 1.05 μ H, Cap + Board total-ESR < 20 m Ω , C _{out} > 1.9 μ F, ESL<200 pH				
PWM mode peak efficiency	Peak efficiency at 200 mA load, inductor DCR = 200 m Ω , VBAT = 3.6V, VOUT = 1.35V	_	85	_	%
PFM mode efficiency	10 mA load current, inductor DCR = 200 mΩ, VBAT = 3.6V, VOUT = 1.35V	_	77	-	%
Start-up time from power down	VDDIO already ON and steady. Time from REG_ON rising edge to CLDO reaching 1.2V	_	400	500	μs
External inductor	0603 size, 2.2 μH ±20%, DCR = 0.2Ω ± 25%	_	2.2	_	μH
External output capacitor	Ceramic, X5R, 0402, ESR <30 mΩ at 4 MHz, 4.7 μF ±20%, 10V	, 2.0 ^b	4.7	10 ^c	μF

Table 21: Core Buck Switching Regulator (CBUCK) Specifications (Cont.)

Specification	Notes	Min.	Тур.	Мах.	Units
External input capacitor	For SR_VDDBATP5V pin, ceramic, X5R, 0603, ESR < 30 m Ω at 4 MHz, ±4.7 μ F ±20%, 10V	0.67 ^b	4.7	_	μF
Input supply voltage ramp-up time	0 to 4.3V	40	_	_	μs

- a. The maximum continuous voltage is 4.8V. Voltages up to 6.0V for up to 10 seconds, cumulative duration, over the lifetime of the device are allowed. Voltages as high as 5.0V for up to 250 seconds, cumulative duration, over the lifetime of the device are allowed.
- b. Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.
- c. Total capacitance includes those connected at the far end of the active load.

3.3V LDO (LDO3P3)

Table 22: LDO3P3 Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage, V _{in}	Min. = V _o + 0.2V = 3.5V dropout voltage requirement must be met under maximum load for performance specifications.	3.1	3.6	4.8 ^a	V
Output current	_	0.001	_	450	mA
Nominal output voltage, V _o	Default = 3.3V.	_	3.3	_	V
Dropout voltage	At max. load.	_	_	200	mV
Output voltage DC accuracy	Includes line/load regulation.	- 5	_	+5	%
Quiescent current	No load	_	66	85	μA
Line regulation	V_{in} from (V_{o} + 0.2V) to 4.8V, max. load	_	_	3.5	mV/V
Load regulation	load from 1 mA to 450 mA	_	_	0.3	mV/mA
PSRR	$V_{in} \ge V_o + 0.2V$, $V_o = 3.3V$, $C_o = 4.7 \mu F$, Max. load, 100 Hz to 100 kHz	20	-	-	dB
LDO turn-on time	Chip already powered up.	_	160	250	μs
External output capacitor, Co	Ceramic, X5R, 0402, (ESR: 5 mΩ–240 mΩ), ± 10%, 10V	1.0 ^b	4.7	5.64	μF
External input capacitor	For SR_VDDBATA5V pin (shared with band gap) Ceramic, X5R, 0402, (ESR: $30m-200~m\Omega$), $\pm~10\%$, $10V$. Not needed if sharing VBAT capacitor $4.7~\mu\text{F}$ with SR_VDDBATP5V.	-	4.7	-	μF

a. The maximum continuous voltage is 4.8V. Voltages up to 6.0V for up to 10 seconds, cumulative duration, over the lifetime of the device are allowed. Voltages as high as 5.0V for up to 250 seconds, cumulative duration, over the lifetime of the device are allowed.

b. Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.

CLDO

Table 23: CLDO Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage, V _{in}	Min. = 1.2 + 0.15V = 1.35V dropout voltage requirement must be met under maximum load.	1.3	1.35	1.5	V
Output current	-	0.2	_	200	mA
Output voltage, V _o	Programmable in 10 mV steps. Default = 1.2.V	0.95	1.2	1.26	V
Dropout voltage	At max. load	_	_	150	mV
Output voltage DC accuracy	Includes line/load regulation	-4	_	+4	%
Quiescent current	No load	_	13	_	μA
	200 mA load	_	1.24	_	mA
Line regulation	V _{in} from (V _o + 0.15V) to 1.5V, maximum load	_	-	5	mV/V
Load regulation	Load from 1 mA to 300 mA	_	0.02	0.05	mV/mA
Leakage current	Power down	_	5	20	μΑ
	Bypass mode	_	1	3	μA
PSRR	@1 kHz, Vin ≥ 1.35V, C _o = 4.7 μF	20	_	_	dB
Start-up time of PMU	VDDIO up and steady. Time from the REG_ON rising edge to the CLDO reaching 1.2V.	-	_	700	μs
LDO turn-on time	LDO turn-on time when rest of the chip is up.	_	140	180	μs
External output capacitor, Co	Total ESR: 5 mΩ–240 mΩ	1.1 ^a	2.2	_	μF
External input capacitor	Only use an external input capacitor at the VDD_LDO pin if it is not supplied from CBUCK output.	_	1	2.2	μF

a. Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.

LNLDO

Table 24: LNLDO Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage, Vin	Min. $V_{IN} = V_O + 0.15V = 1.35V$ (where $V_O = 1.2V$) dropout voltage requirement must be met under maximum load.	1.3	1.35	1.5	V
Output current	_	0.1	_	150	mA
Output voltage, V _o	Programmable in 25 mV steps. Default = 1.2V	1.1	1.2	1.275	V
Dropout voltage	At maximum load	_	_	150	mV
Output voltage DC accuracy	Includes line/load regulation	-4	_	+4	%
Quiescent current	No load	_	10	12	μΑ
	Max. load	_	970	990	μΑ
Line regulation	V _{in} from (V _o + 0.15V) to 1.5V, 200 mA load	-	_	5	mV/V
Load regulation	Load from 1 mA to 200 mA: $V_{in} \ge (V_o + 0.12V)$	_	0.025	0.045	mV/mA
Leakage current	Power-down, junction temp. = 85°C	_	5	20	μΑ
Output noise	@30 kHz, 60–150 mA load C_0 = 2.2 μ F	-	-	60 35	–nV/√ <i>Hz</i>
PSRR	@1 kHz, $V_{in} \ge (V_o + 0.15V)$, $C_o = 4.7 \mu F$	20	_	_	dB
LDO turn-on time	LDO turn-on time when rest of chip is up	_	140	180	μs
External output capacitor, Co	Total ESR (trace/capacitor): 5 m Ω –240 m Ω	0.5 ^a	2.2	4.7	μF
External input capacitor	Only use an external input capacitor at the VDD_LDO pin if it is not supplied from CBUCK output. Total ESR (trace/capacitor): $30 \text{ m}\Omega$ – $200 \text{ m}\Omega$	_)	1	2.2	μF

a. Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.

Section 12: System Power Consumption



Note: The values in this data sheet are design goals and are subject to change based on device characterization. Unless otherwise stated, these values apply for the conditions specified in Table 16: "Recommended Operating Conditions and DC Characteristics," on page 56.

WLAN Current Consumption

Table 25 shows typical currents consumed by the BCM43364's WLAN section.

2.4 GHz Mode

Table 25: 2.4 GHz Mode WLAN Power Consumption

		VBAT = 3.6V,	VDDIO = 1.8V, TA 25°C
Mode	Rate	VBAT (mA)	Vio (μA)
Sleep Modes			
Leakage (OFF)	N/A	0.0035	0.08
Sleep (idle, unassociated) ^a	N/A	0.0058	80
Sleep (idle, associated, inter-beacons) b	Rate 1	0.0058	80
IEEE Power Save PM1 DTIM1 (Avg.) ^c	Rate 1	1.05	74
IEEE Power Save PM1 DTIM3 (Avg.) d	Rate 1	0.35	86
IEEE Power Save PM2 DTIM1 (Avg.) ^c	Rate 1	1.05	74
IEEE Power Save PM2 DTIM3 (Avg.) d	Rate 1	0.35	86
Active Modes			
Rx Listen Mode ^e	N/A	37	12
Rx Active (at –50dBm RSSI) ^f	Rate 1	39	12
,	Rate 11	40	12
	Rate 54	40	12
	Rate MCS7	41	12
Tx ^f	Rate 1 @ 20 dBm	320	15
	Rate 11 @ 18 dBm	290	15
	Rate 54 @ 15 dBm	260	15
	Rate C7 @ 15 dBm	260	15

- a. Device is initialized in Sleep mode, but not associated.
- b. Device is associated, and then enters Power Save mode (idle between beacons).
- c. Beacon interval = 100 ms; beacon duration = 1 ms @ 1 Mbps (Integrated Sleep + wakeup + beacon).
- d. Beacon interval = 300 ms; beacon duration = 1 ms @ 1 Mbps (Integrated Sleep + wakeup + beacon).
- e. Carrier sense (CCA) when no carrier present.
- f. Tx output power is measured on the chip-out side; duty cycle =100%. Tx Active mode is measured in Packet Engine mode (pseudo-random data)

Section 13: Interface Timing and AC Characteristics



Note: Values in this data sheet are design goals and are subject to change based on the results of device characterization.

Unless otherwise stated, the specifications in this section apply when the operating conditions are within the limits specified in Table 14 on page 56 and Table 16 on page 56. Functional operation outside of these limits is not guaranteed.

SDIO Default Mode Timing

SDIO default mode timing is shown by the combination of Figure 24 and Table 26 on page 72.

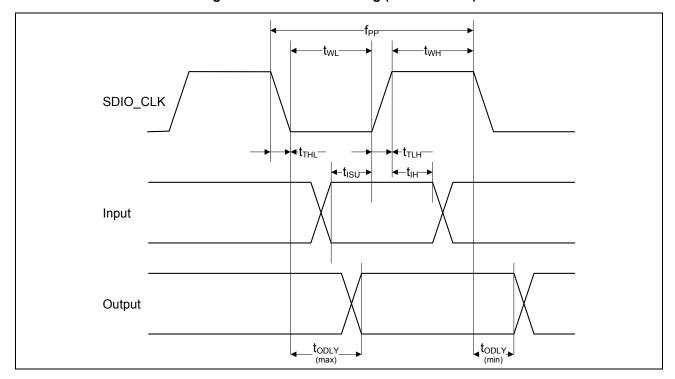


Figure 24: SDIO Bus Timing (Default Mode)

Table 26: SDIO Bus Timing ^a Parameters (Default Mode)

Parameter	Symbol	Minimum	Typical	Maximum	Unit				
SDIO CLK (All values are referred to minimum VIH and maximum VIL ^b)									
Frequency—Data Transfer mode	fPP	0	_	25	MHz				
Frequency—Identification mode	fOD	0	_	400	kHz				
Clock low time	tWL	10	_	_	ns				
Clock high time	tWH	10	_	_	ns				
Clock rise time	tTLH	_	_	10	ns				
Clock fall time	tTHL	_	_	10	ns				
Inputs: CMD, DAT (referenced to CLK)									
Input setup time	tISU	5	_	_	ns				
Input hold time	tIH	5	_	_	ns				
Outputs: CMD, DAT (referenced to CLK)									
Output delay time—Data Transfer mode	tODLY	0	_	14	ns				
Output delay time—Identification mode	tODLY	0	_	50	ns				

a. Timing is based on $CL \le 40 \ pF$ load on command and data.

b. Min (Vih) = $0.7 \times VDDIO$ and max (Vil) = $0.2 \times VDDIO$.

SDIO High-Speed Mode Timing

SDIO high-speed mode timing is shown by the combination of Figure 25 and Table 27.

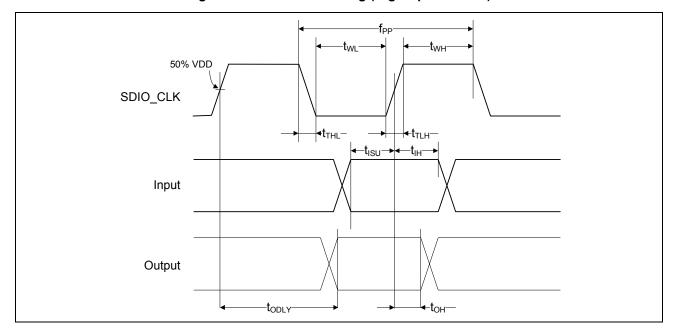


Figure 25: SDIO Bus Timing (High-Speed Mode)

Table 27: SDIO Bus Timing ^a Parameters (High-Speed Mode)

Parameter	Symbol	Minimum	Typical	Maximum	Unit				
SDIO CLK (all values are referred to minimum VIH and maximum VIL ^b)									
Frequency – Data Transfer Mode	fPP	0	_	50	MHz				
Frequency – Identification Mode	fOD	0	_	400	kHz				
Clock low time	tWL	7	_	_	ns				
Clock high time	tWH	7	_	_	ns				
Clock rise time	tTLH	_	_	3	ns				
Clock fall time	tTHL	_	_	3	ns				
Inputs: CMD, DAT (referenced to CLK)									
Input setup time	tISU	6	_	_	ns				
Input hold time	tIH	2	_	_	ns				
Outputs: CMD, DAT (referenced to CLK)	Outputs: CMD, DAT (referenced to CLK)								
Output delay time – Data Transfer Mode	tODLY	_	_	14	ns				
Output hold time	tOH	2.5	_	_	ns				
Total system capacitance (each line)	CL	_	_	40	pF				

a. Timing is based on $CL \le 40$ pF load on command and data.

b. Min (Vih) = $0.7 \times VDDIO$ and max (ViI) = $0.2 \times VDDIO$.

gSPI Signal Timing

The gSPI device always samples data on the rising edge of the clock.

SPI_DOUT (falling edge)

Figure 26: gSPI Timing

Table 28: gSPI Timing Parameters

Parameter	Symbol	Minimum	Maximum	Units	Note
Clock period	T1	20.8	_	ns	F _{max} = 50 MHz
Clock high/low	T2/T3	(0.45 × T1) – T4	(0.55 × T1) – T4	ns	-
Clock rise/fall time	T4/T5	_	2.5	ns	-
Input setup time	T6	5.0	_	ns	Setup time, SIMO valid to SPI_CLK active edge
Input hold time	T7	5.0	_	ns	Hold time, SPI_CLK active edge to SIMO invalid
Output setup time	T8	5.0	-	ns	Setup time, SOMI valid before SPI_CLK rising
Output hold time	Т9	5.0	-	ns	Hold time, SPI_CLK active edge to SOMI invalid
CSX to clock ^a	_	7.86	_	ns	CSX fall to 1st rising edge
Clock to CSX ^c	_	_	_	ns	Last falling edge to CSX high

a. SPI_CSx remains active for entire duration of gSPI read/write/write_read transaction (that is, overall words for multiple word transaction).

JTAG Timing

Table 29: JTAG Timing Characteristics

Signal Name	Period	Output Maximum	Output Minimum	Setup	Hold
TCK	125 ns	_	_	_	-
TDI	-	_	_	20 ns	0 ns
TMS	_	_	_	20 ns	0 ns
TDO	_	100 ns	0 ns	-	-
JTAG_TRST	250 ns	_	_	_	_

Section 14: Power-Up Sequence and Timing

Sequencing of Reset and Regulator Control Signals

The BCM43364 WL_REG_ON signal allows the host to control power consumption by enabling or disabling the WLAN and internal regulator blocks. These signals are described below. Additionally, diagrams are provided to indicate proper sequencing of the signals for various operational states (see Figure 27 and Figure 28). The timing values indicated are minimum required values; longer delays are also acceptable.



Note:

- The BCM43364 has an internal power-on reset (POR) circuit. The device will be held in reset for a maximum of 110 ms after VDDC and VDDIO have both passed the POR threshold (see Table 16: "Recommended Operating Conditions and DC Characteristics," on page 56). Wait at least 150 ms after VDDC and VDDIO are available before initiating SDIO accesses.
- VBAT and VDDIO should not rise faster than 40 μs. VBAT should be up before or at the same time as VDDIO. VDDIO should not be present first or be held high before VBAT is high.

Control Signal Timing Diagrams

Figure 27: WLAN = ON

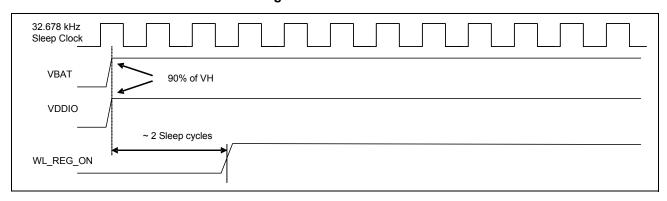
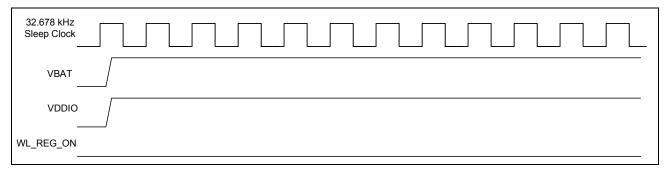


Figure 28: WLAN = OFF



Section 15: Package Information

Package Thermal Characteristics

Table 30: Package Thermal Characteristics^a

Value in Still Air	
53.11	
13.14	
6.36	
0.04	
14.21	
125	
1.2	
	53.11 13.14 6.36 0.04 14.21 125

- a. No heat sink, TA = 70°C. This is an estimate based on a 4-layer PCB that conforms to EIA/JESD51–7 (101.6 mm x 114.3 mm x 1.6 mm) and P = 1.2W continuous dissipation.
- b. Absolute junction temperature limits maintained through active thermal monitoring and dynamic TX duty cycle limiting.

Junction Temperature Estimation and PSI Versus Theta_{ic}

Package thermal characterization parameter PSI-JT (\varPsi_{JT}) yields a better estimation of actual junction temperature (T_J) versus using the junction-to-case thermal resistance parameter Theta- J_C (θ_{JC}). The reason for this is θ_{JC} assumes that all the power is dissipated through the top surface of the package case. In actual applications, some of the power is dissipated through the bottom and sides of the package. \varPsi_{JT} takes into account power dissipated through the top, bottom, and sides of the package. The equation for calculating the device junction temperature is as follows:

$$T_J = T_T + P \times \Psi_{JT}$$

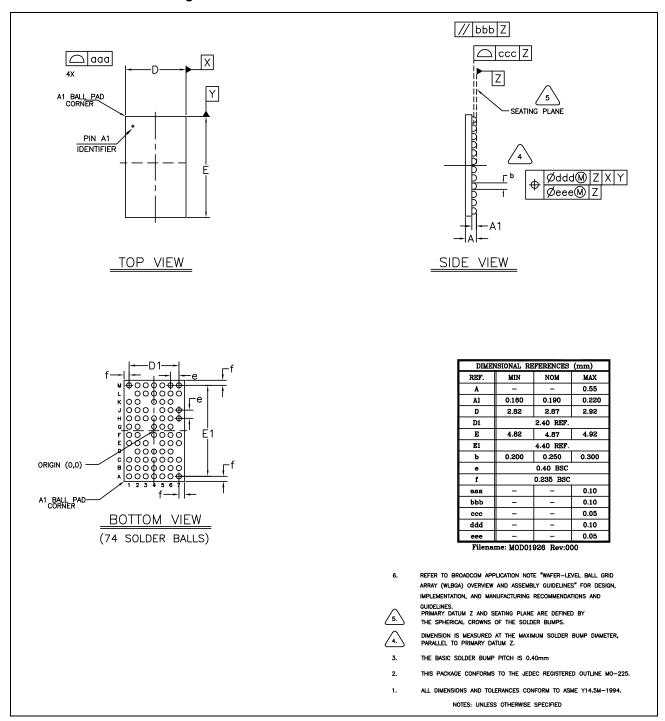
Where:

- T_J = junction temperature at steady-state condition, °C
- T_T = package case top center temperature at steady-state condition, °C
- P = device power dissipation, Watts
- Ψ_{JT} = package thermal characteristics (no airflow), °C/W

Section 16: Mechanical Information

Figure 29 shows the mechanical drawing for the BCM43364 WLBGA package.

Figure 29: 74-Ball WLBGA Mechanical Information



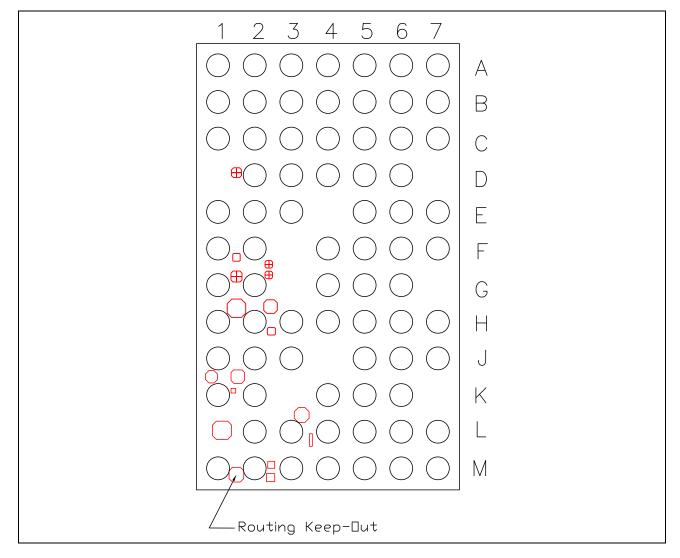


Figure 30: WLBGA Package Keep-Out Areas—Top View with the Bumps Facing Down

Section 17: Ordering Information

Part Number ^a	Package	Description	Operating Ambient Temperature
BCM43364KUBG	74-ball WLBGA halogen-free package (4.87 mm x 2.87 mm, 0.40 pitch)	e 2.4 GHz single-band WLAN IEEE 802.11n	–30°C to +70°C

a. Add a "T" to the end of the part number to specify "Tape and Reel."

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E-mail: info@broadcom.com Web: www.broadcom.com

Phone: 949-926-5000 Fax: 949-926-5203